

TEST REPORT

APPLICANT : Sharp Corporation, Communication Systems Group
ADDRESS : 2-13-1, Iida Hachihonmatsu, Higashi-Hiroshima City, Hiroshima,
739-0192, JAPAN
PRODUCTS : Cellular Phone
MODEL NO. : SH80F
SERIAL NO. : 004401113527218
004401113527275
FCC ID : APYHRO00156
TEST STANDARD : CFR 47 FCC Rules and Regulations Part 15
TESTING LOCATION : Japan Quality Assurance Organization
KITA-KANSAI Testing Center
1-7-7, Ishimaru, Minoh-shi, Osaka 562-0027, Japan
TEST RESULTS : **Passed**
DATE OF TEST : July 22, 2011 ~ August 17, 2011



A handwritten signature in black ink, appearing to read 'K. Shibata'.

Kousei Shibata
Manager
Japan Quality Assurance Organization
KITA-KANSAI Testing Center
Testing Dept. SAITO EMC Branch
7-3-10, Saito-asagi, Ibaraki-shi, Osaka 567-0085, Japan

- The measurement values stated in Test Report was made with traceable to National Institute of Advanced Industrial Science and Technology (AIST) of Japan and National Institute of Information and Communications Technology (NICT) of Japan.
- The applicable standard, testing condition and testing method which were used for the tests are based on the request of the applicant.
- The test results presented in this report relate only to the offered test sample.
- The contents of this test report cannot be used for the purposes, such as advertisement for consumers.
- This test report shall not be reproduced except in full without the written approval of JQA.
- VLAC does not approve, certify or warrant the product by this test report.

TABLE OF CONTENTS

	Page
Documentation	3
1 Test Regulation.....	3
2 Test Location.....	3
3 Recognition of Test Laboratory.....	3
4 Description of the Equipment Under Test.....	4
5 Test Condition.....	5
6 Preliminary Test and Test Setup	7
7 Equipment Under Test Modification.....	14
8 Responsible Party	14
9 Deviation from Standard.....	14
10 Test Results.....	15
11 Summary	18
12 Operating Condition.....	19
13 Test Configuration.....	19
14 Equipment Under Test Arrangement (Drawings)	20
Appendix A: Test Data	21
Appendix B: Test Arrangement (Photographs)	53
Appendix C: Test Instruments.....	55

DEFINITIONS FOR ABBREVIATION AND SYMBOLS USED IN THIS TEST REPORT

EUT : Equipment Under Test	EMC : Electromagnetic Compatibility
AE : Associated Equipment	EMI : Electromagnetic Interference
N/A : Not Applicable	EMS : Electromagnetic Susceptibility
N/T : Not Tested	

- ☒ - indicates that the listed condition, standard or equipment is applicable for this report.
☐ - indicates that the listed condition, standard or equipment is not applicable for this report.

Documentation

1 Test Regulation

Applied Standard : CFR 47 FCC Rules and Regulations Part 15
Subpart C – Intentional Radiators

Test Requirements : §15.247, §15.207 and §15.209

Test Procedure : ANSI C63.4–2003

The tests were performed with reference to the FCC Public Notice DA 00-705, released March 30, 2000.
The test set-up was made in accordance to the general provisions of ANSI C63.4-2003.

2 Test Location

Japan Quality Assurance Organization (JQA)
KITA-KANSAI Testing Center Testing Department SAITO EMC Branch
7-3-10, Saito-asagi, Ibaraki-shi, Osaka 567-0085, Japan
MINOH Test Site (KITA-KANSAI Testing Center)
7-7, Ishimaru, 1-chome, Minoh-shi, Osaka, 562-0027, Japan
KAMEOKA EMC Branch
9-1, Ozaki, Inukanno, Nishibetsuin-cho, Kameoka-shi, Kyoto, 621-0126, Japan

3 Recognition of Test Laboratory

JQA KITA-KANSAI Testing Center Testing Dept. SAITO EMC Branch is accredited under ISO/IEC 17025 by following accreditation bodies and the test facility of Testing Division is registered by the following bodies.

VLAC Code : VLAC-001-2 (Effective through : March 30, 2012)
BSMI Recognition No. : SL2-IS-E-6006, SL2-IN-E-6006, SL2-AI-E-6006
(Effective through : September 14, 2013)
IC Registration No. : 2079E-2 (Effective through : January 25, 2014)
2079E-3, 2079E-4 (Effective through : July 20, 2014)

Accredited as conformity assessment body for Japan electrical appliances and material law by METI.
(Effective through : February 22, 2012)

4 Description of the Equipment Under Test

4.1 General Information

1. Manufacturer : Sharp Corporation, Communication Systems Group
2-13-1, Iida Hachihonmatsu, Higashi-Hiroshima City, Hiroshima,
739-0192, JAPAN
2. Products : Cellular Phone
3. Model No. : SH80F
4. Serial No. : 004401113527218
: 004401113527275
5. Product Type : Pre-production
6. Date of Manufacture : June, 2011
7. Transmitting Frequency : 2402.0 MHz(00CH) –2480.0MHz(78CH)
8. Receiving Frequency : 2402.0 MHz(00CH) –2480.0MHz(78CH)
9. Max. RF Output Power : 2.51dBm(Measure Value)
10. Power Rating : 4.0VDC (Lithium-ion Battery Pack SH30 1240mAh)
11. EUT Grounding : None
12. Category : Spread Spectrum Transmitter(FHSS).
13. EUT Authorization : Certification
14. Receive Date of EUT : July 12, 2011

4.2 Channel Plan

The carrier spacing is 1 MHz.

The carrier frequency is designated by the absolute frequency channel number (ARFCN).

The carrier frequency is expressed in the equation shown as follows:

Transmitting Frequency (in MHz) = $2402.0 + n$

Receiving Frequency (in MHz) = $2402.0 + n$

where, n : channel number ($0 \leq n \leq 78$)

5 Test Condition

5.1 Channel Separation

The requirements are ☒ - Applicable ☒ - Tested. ☐ - Not tested by applicant request.]
☐ - Not Applicable

Test site : SAITO	☐ - Shielded room (S1)	☐ - Shielded room (S2)
	☒ - Shielded room (S3)	☐ - Shielded room (S4)
MINOH	☐ - Shielded room	☐ - 2nd shielded room
KAMEOKA	☐ - Shielded room	☐ - Conducted emission facility

Test instruments : Refer to Appendix C.

5.2 Minimum Hopping Channel

The requirements are ☒ - Applicable ☒ - Tested. ☐ - Not tested by applicant request.]
☐ - Not Applicable

Test site : SAITO	☐ - Shielded room (S1)	☐ - Shielded room (S2)
	☒ - Shielded room (S3)	☐ - Shielded room (S4)
MINOH	☐ - Shielded room	☐ - 2nd shielded room
KAMEOKA	☐ - Shielded room	☐ - Conducted emission facility

Test instruments : Refer to Appendix C.

5.3 Occupied Bandwidth

The requirements are ☒ - Applicable ☒ - Tested. ☐ - Not tested by applicant request.]
☐ - Not Applicable

Test site : SAITO	☐ - Shielded room (S1)	☐ - Shielded room (S2)
	☒ - Shielded room (S3)	☐ - Shielded room (S4)
MINOH	☐ - Shielded room	☐ - 2nd shielded room
KAMEOKA	☐ - Shielded room	☐ - Conducted emission facility

Test instruments : Refer to Appendix C.

5.4 Dwell Time

The requirements are ☒ - Applicable ☒ - Tested. ☐ - Not tested by applicant request.]
☐ - Not Applicable

Test site : SAITO	☐ - Shielded room (S1)	☐ - Shielded room (S2)
	☒ - Shielded room (S3)	☐ - Shielded room (S4)
MINOH	☐ - Shielded room	☐ - 2nd shielded room
KAMEOKA	☐ - Shielded room	☐ - Conducted emission facility

Test instruments : Refer to Appendix C.

5.5 Peak Output Power (Conduction)

The requirements are ☒ - Applicable ☒ - Tested. ☐ - Not tested by applicant request.]
☐ - Not Applicable

Test site :	SAITO	☐ - Shielded room (S1)	☐ - Shielded room (S2)
		☒ - Shielded room (S3)	☐ - Shielded room (S4)
	MINOH	☐ - Shielded room	☐ - 2nd shielded room
	KAMEOKA	☐ - Shielded room	☐ - Conducted emission facility

Test instruments : Refer to Appendix C.

5.6 Spurious Emission (Conduction)

The requirements are ☒ - Applicable ☒ - Tested. ☐ - Not tested by applicant request.]
☐ - Not Applicable

Test site :	SAITO	☐ - Shielded room (S1)	☐ - Shielded room (S2)
		☒ - Shielded room (S3)	☐ - Shielded room (S4)
	MINOH	☐ - Shielded room	☐ - 2nd shielded room
	KAMEOKA	☐ - Shielded room	☐ - Conducted emission facility

Test instruments : Refer to Appendix C.

5.7 AC Powerline Conducted Emission

The requirements are ☒ - Applicable ☒ - Tested. ☐ - Not tested by applicant request.]
☐ - Not Applicable

Test site :	SAITO	☐ - Anechoic chamber (A1)	☐ - Measurement room (M1)
		☐ - Measurement room (M2)	☐ - Measurement room (M3)
		☐ - Shielded room (S1)	☒ - Shielded room (S2)
	MINOH	☐ - Shielded room	☐ - 2nd shielded room
		☐ - Anechoic chamber	
	KAMEOKA	☐ - Shielded room	☐ - Conducted emission facility
		☐ - 1st open site	

Test instruments : Refer to Appendix C.

5.8 Field Strength of Spurious Radiation

The requirements are ☒ - Applicable ☒ - Tested. ☐ - Not tested by applicant request.]
☐ - Not Applicable

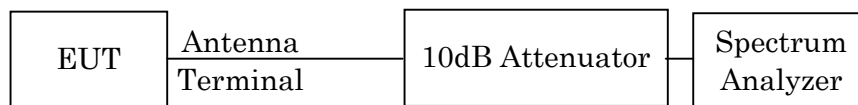
Test site :	SAITO	☐ - Anechoic chamber (A1)	☒ - Anechoic chamber (A2)
	KAMEOKA	☐ - 1st open site	

Test instruments : Refer to Appendix C.

6 Preliminary Test and Test Setup

6.1 Channel Separation

The test system is shown as follows:

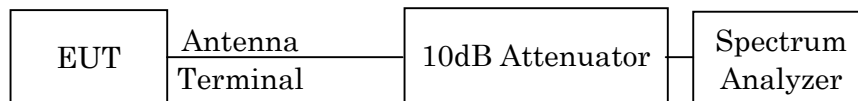


The setting of the spectrum analyzer are shown as follows:

Res. Bandwidth	100 kHz
Video Bandwidth	300 kHz
Span	3 MHz / 5 MHz
Sweep Time	AUTO
Trace	Maxhold

6.2 Minimum Hopping Channel

The test system is shown as follows:

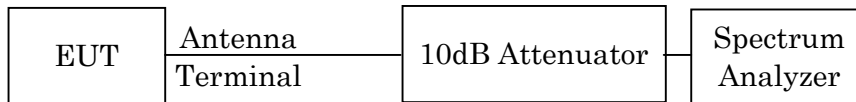


The setting of the spectrum analyzer are shown as follows:

Res. Bandwidth	300 kHz
Video Bandwidth	300 kHz
Span	30 MHz
Sweep Time	AUTO
Trace	Maxhold

6.3 Occupied Bandwidth

The test system is shown as follows:

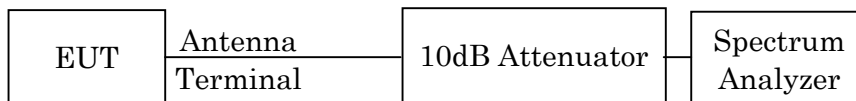


The setting of the spectrum analyzer are shown as follows:

Res. Bandwidth	10 kHz
Video Bandwidth	30 kHz
Span	3 MHz
Sweep Time	AUTO
Trace	Maxhold

6.4 Dwell Time

The test system is shown as follows:

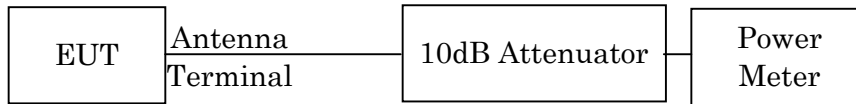


The setting of the spectrum analyzer are shown as follows:

Res. Bandwidth	1 MHz
Video Bandwidth	1 MHz
Span	Zero Span

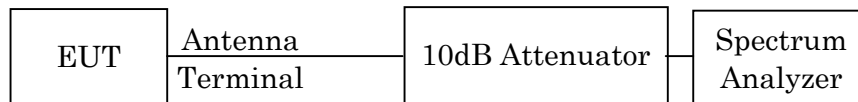
6.5 Peak Output Power

The Conducted RF Power Output was measured with a power meter, one 10dB attenuator and a short, low loss cable.



6.6 Spurious Emission(Conduction)

The test system is shown as follows:



The setting of the spectrum analyzer are shown as follows:

Frequency Range	30 MHz - 25 GHz	Band-Edge
Res. Bandwidth	100 kHz	100 kHz
Video Bandwidth	300 kHz	300 kHz
Sweep Time	AUTO	AUTO
Trace	Maxhold	Maxhold

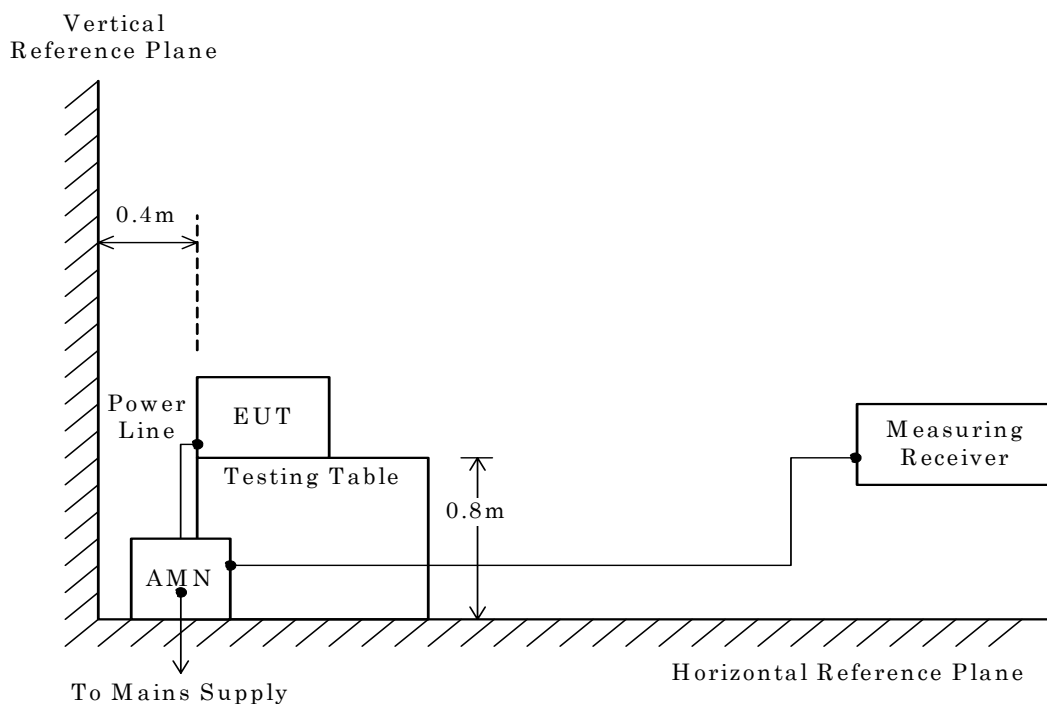
6.7 AC Powerline Conducted Emission

The preliminary tests were performed using the scan mode of test receiver or spectrum analyzer to observe the emissions characteristics of the EUT.

The EUT configuration, cable configuration and mode of operation were determined for producing the maximum level of emissions.

This configurations was used for final tests.

– Side View –



NOTE

AMN : Artificial Mains Network

6.8 Field Strength of Spurious Emission

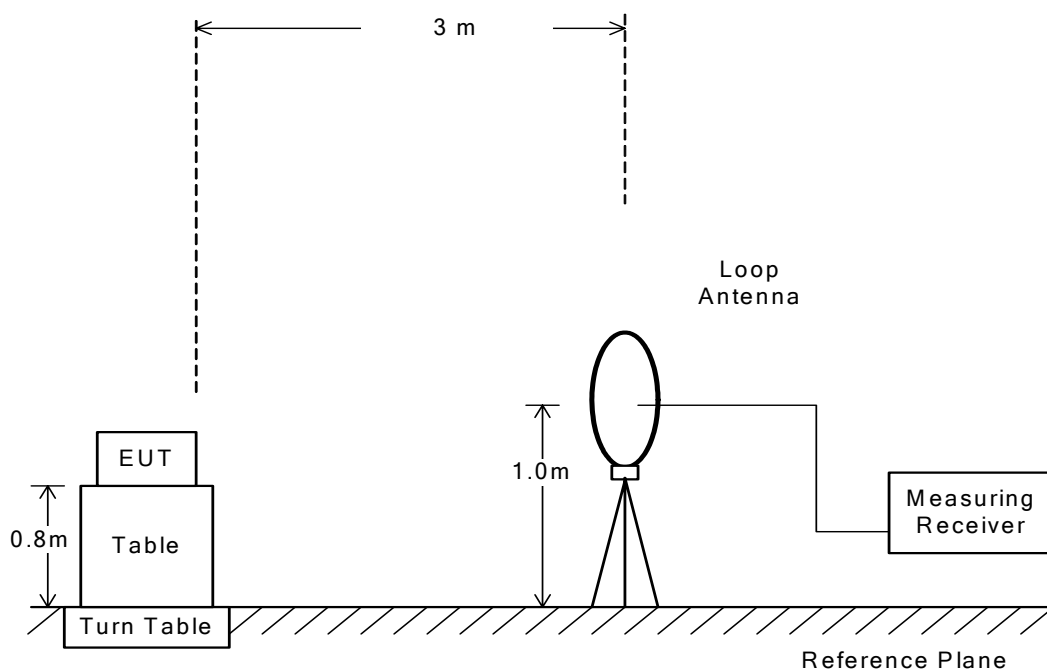
6.8.1 Field Strength of Spurious Emission 9 kHz – 30 MHz

The preliminary tests were performed at the measurement distance that specified for compliance to determine the emission characteristics of the EUT.

The EUT configuration(in X, Y and Z axis), cable configuration and mode of operation were determined for producing the maximum level of emissions.

This configurations was used for the final tests.

– Side View –



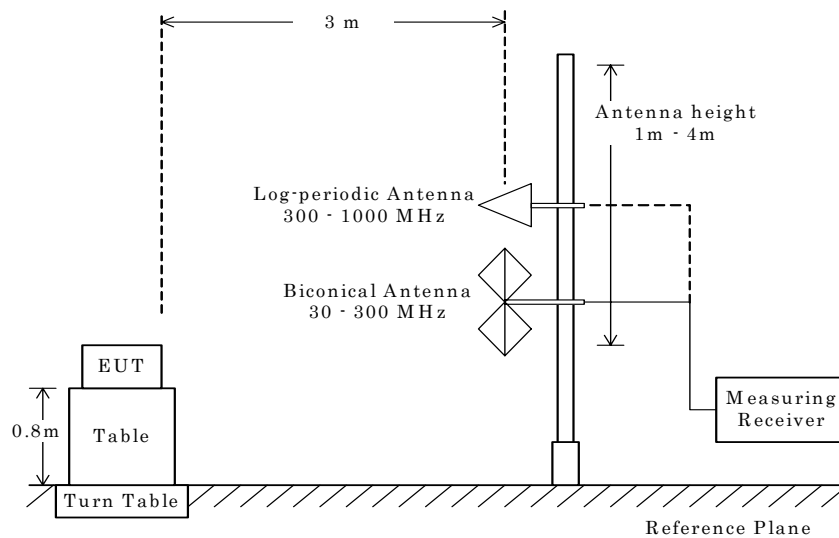
6.8.2 Field Strength of Spurious Emission 30 MHz – 1000 MHz

The preliminary tests were performed at the measurement distance that specified for compliance to determine the emission characteristics of the EUT.

The EUT configuration(in X, Y and Z axis), cable configuration and mode of operation were determined for producing the maximum level of emissions.

This configurations was used for the final tests.

– Side View –



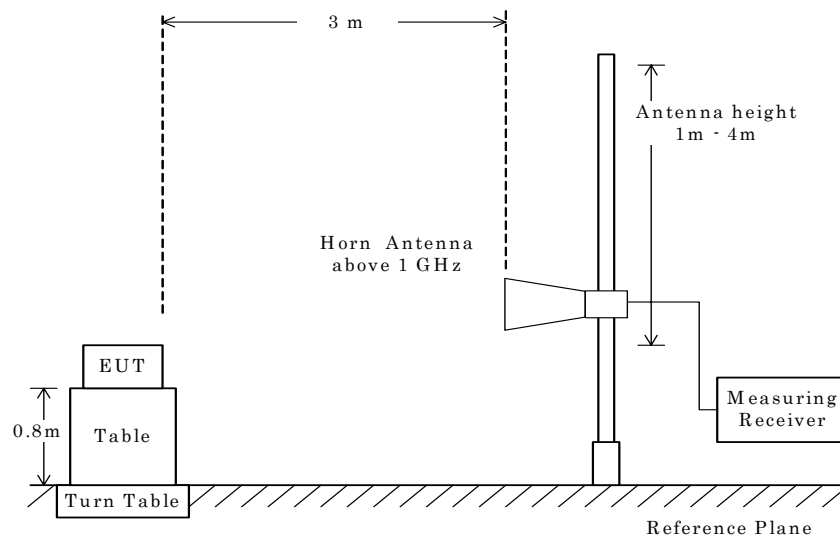
6.8.3 Field Strength of Spurious Emission above 1 GHz

The preliminary tests were performed at the measurement distance that specified for compliance to determine the emission characteristics of the EUT.

The EUT configuration(in X, Y and Z axis), cable configuration and mode of operation were determined for producing the maximum level of emissions.

This configurations was used for the final tests.

– Side View –



NOTE

The antenna height is scanned depending on the EUT's size and mounting height.

7 Equipment Under Test Modification

- ☒ - No modifications were conducted by JQA to achieve compliance to the limitations.
☐ - To achieve compliance to the limitations, the following changes were made by JQA during the compliance test.

The modifications will be implemented in all production models of this equipment.

Applicant : Not Applicable

Date : Not Applicable

Typed Name : Not Applicable

Position : Not Applicable

Signatory : Not Applicable

8 Responsible PartyResponsible Party of Test Item (Product)

Responsible Party :

Contact Person :

Signatory

9 Deviation from Standard

- ☒ - No deviations from the standard described in clause 1.
☐ - The following deviations were employed from the standard described in clause 1.

10 Test Results**10.1 RF Power Output (§2.1046)****10.1.1 Channel Separation**

The requirements are ☒ - Applicable ☒ - Tested. ☐ - Not tested by applicant request.]
☐ - Not Applicable

☒ - Passed ☐ - Failed ☐ - Not judged

Channel Separation is 1.002 MHz
Channel Separation(Inquiry) is 2.000 MHz

Uncertainty of Measurement Results +/-0.9 %(2σ)

Remarks : _____

10.1.2 Minimum Hopping Channel

The requirements are ☒ - Applicable ☒ - Tested. ☐ - Not tested by applicant request.]
☐ - Not Applicable

Number of Channel is 79
Number of Channel (Inquiry) is 32

Remarks : _____

10.1.3 Occupied Bandwidth

The requirements are ☒ - Applicable ☐ - Tested. ☐ - Not tested by applicant request.]
☐ - Not Applicable

☒ - Passed ☐ - Failed ☐ - Not judged

The 99% Bandwidth is 1175.9 kHz at 2402.0 MHz
The 20dB Bandwidth is 1314.0 kHz at 2441.0 MHz

Uncertainty of Measurement Results +/-0.9 %(2σ)

Remarks : _____

10.1.4 Dwell Time

The requirements are ☒ - Applicable ☒ - Tested. ☐ - Not tested by applicant request.]
☐ - Not Applicable

☒ - Passed ☐ - Failed ☐ - Not judged

Dwell Time is 308.1 msec
Dwell Time (Inquiry) is 64.5 msec

Uncertainty of Measurement Results +/-0.6 %(2σ)

Remarks : _____

10.1.5 Peak Output Power(Conduction)

The requirements are ☒ - Applicable ☒ - Tested. ☐ - Not tested by applicant request.]
☐ - Not Applicable

Transmitter Power is 2.51 dBm at 2480.0 MHz

Uncertainty of Measurement Results at Amplitude +/-0.8 dB(2σ)

Remarks : _____

10.1.6 Spurious Emissions(Conduction)

The requirements are ☒ - Applicable ☒ - Tested. ☐ - Not tested by applicant request.]
☐ - Not Applicable

☒ - Passed ☐ - Failed ☐ - Not judged

Uncertainty of Measurement Results
9 kHz – 1GHz +/-1.0 dB(2σ)
1GHz – 18GHz +/-1.2 dB(2σ)
18GHz – 40GHz +/-1.6 dB(2σ)

Remarks : _____

10.1.7 AC Powerline Conducted Emission

The requirements are ☒ - Applicable ☒ - Tested. ☐ - Not tested by applicant request.]
☐ - Not Applicable

☒ - Passed ☐ - Failed ☐ - Not judged

Min. Limit Margin (Quasi-Peak) 22.5 dB at 0.59 MHz

Max. Limit Exceeding (Quasi-Peak) _____ dB at _____ MHz

Uncertainty of Measurement Results +/-2.5 dB(2 σ)

Remarks : _____

10.1.8 Field Strength of Spurious Emission

The requirements are ☒ - Applicable ☒ - Tested. ☐ - Not tested by applicant request.]
☐ - Not Applicable

☒ - Passed ☐ - Failed ☐ - Not judged

Min. Limit Margin (Average) >4.2 dB at 22320.0 MHz

Max. Limit Exceeding (Average) _____ dB at _____ MHz

Uncertainty of Measurement Results

9 kHz – 30 MHz	<u>+/-1.7</u>	dB(2 σ)
30 MHz – 300 MHz	<u>+/-4.3</u>	dB(2 σ)
300 MHz – 1000 MHz	<u>+/-4.5</u>	dB(2 σ)
1 GHz – 18 GHz	<u>+/-4.0</u>	dB(2 σ)
18 GHz – 40 GHz	<u>+/-4.7</u>	dB(2 σ)

Remarks : The measurement result is within the range of measurement uncertainty.

11 Summary**General Remarks :**

The EUT was tested according to the requirements of the following standard.

CFR 47 FCC Rules and Regulations Part 15

The test configuration is shown in clause 12 to 14.

The conclusion for the test items of which are required by the applied regulation is indicated under the test results.

Determining compliance with the limits in this report was based on the results of the compliance measurement, not taking into account measurement instrumentation uncertainty.

Test Results :

The "as received" sample;

- ☒ - fulfill the test requirements of the regulation mentioned on clause 1.
- ☐ - doesn't fulfill the test requirements of the regulation mentioned on clause 1.

Reviewed by:

Tested by:



Shigeru Kinoshita
Deputy Manager
JQA KITA-KANSAI Testing Center
Testing Dept. SAITO EMC Branch



Shigeru Osawa
Deputy Manager
JQA KITA-KANSAI Testing Center
Testing Dept. SAITO EMC Branch

12 Operating Condition

Transmitting/Receiving

Transmitting frequency : 2402.0 MHz(0CH) – 2480.0 MHz(78CH)

Receiver frequency : 2402.0 MHz(0CH) – 2480.0 MHz(78CH)

Modulation Type

1.DH1, DH3, DH5(Modulation Type : GFSK)

2.2DH1, 2DH3, 2DH5(Modulation Type : pi/4-DQPSK)

3.3DH1, 3DH3, 3DH5(Modulation Type : 8DPSK)

Other Clock Frequency

32.768 kHz, 19.2MHz, 27.12 MHz

13 Test Configuration

The equipment under test (EUT) consists of :

	Item	Manufacturer	Model No.	Serial No.	FCC ID
A	Cellular Phone	Sharp	SH80F	0044011135 27218*1) 0044011135 27275*2)	APYHRO00156
B	Lithium-ion Battery	Sharp	SH30	--	N/A
C	AC Charger	Sharp	SHN20(EU)	--	N/A
D	USB Data Cable	Sharp	SHN20(EU)	--	N/A
E	Stereo Handsfree	Sharp	542943	--	N/A

*1) Used for AC Powerline Conducted Emission and Field Strength of Spurious Emission

*2) Used for Antenna Conducted Emission

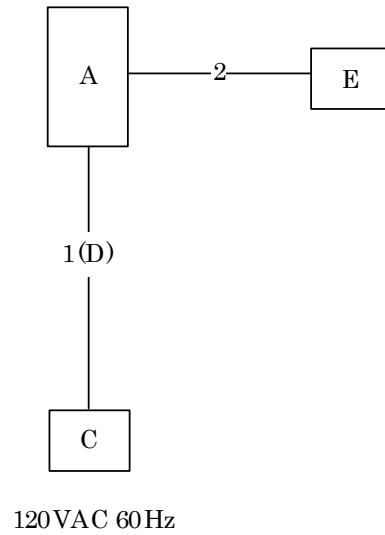
The auxiliary equipment used for testing :

None

Type of Cable:

No.	Description	Identification (Manu. etc.)	Connector Shielded	Cable Shielded	Ferrite Core	Length (m)
1	USB Data Cable	Sharp	YES	YES	NO	0.75
2	Handsfree Cable	--	NO	--	NO	1.5

14 Equipment Under Test Arrangement (Drawings)



Appendix A: Test Data

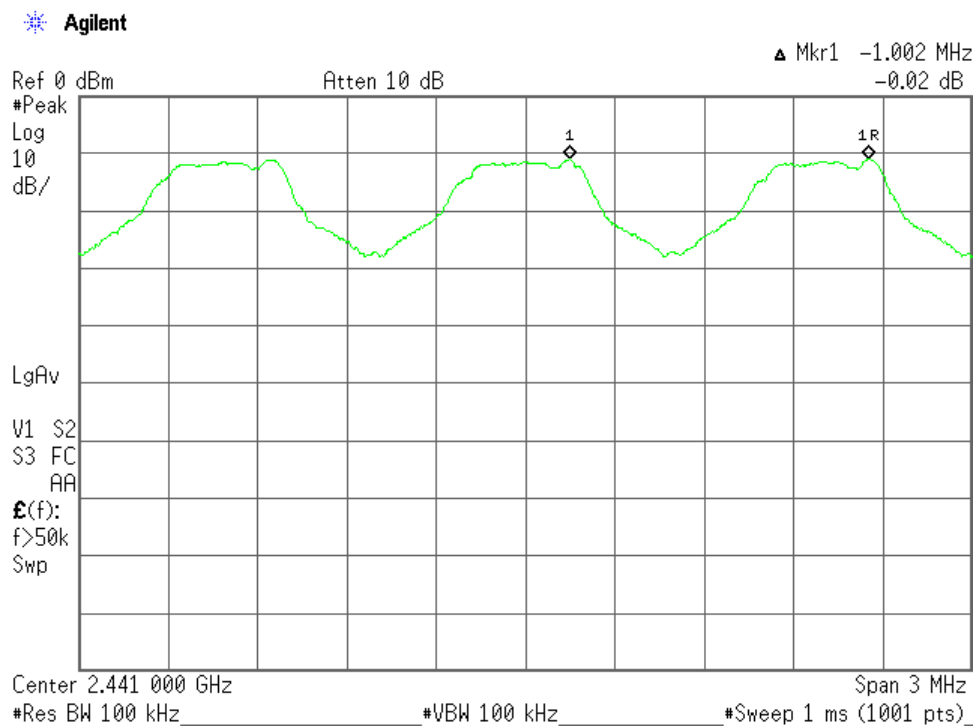
Test Date : July 22, 2011

Temp.:28°C, Humi:66%

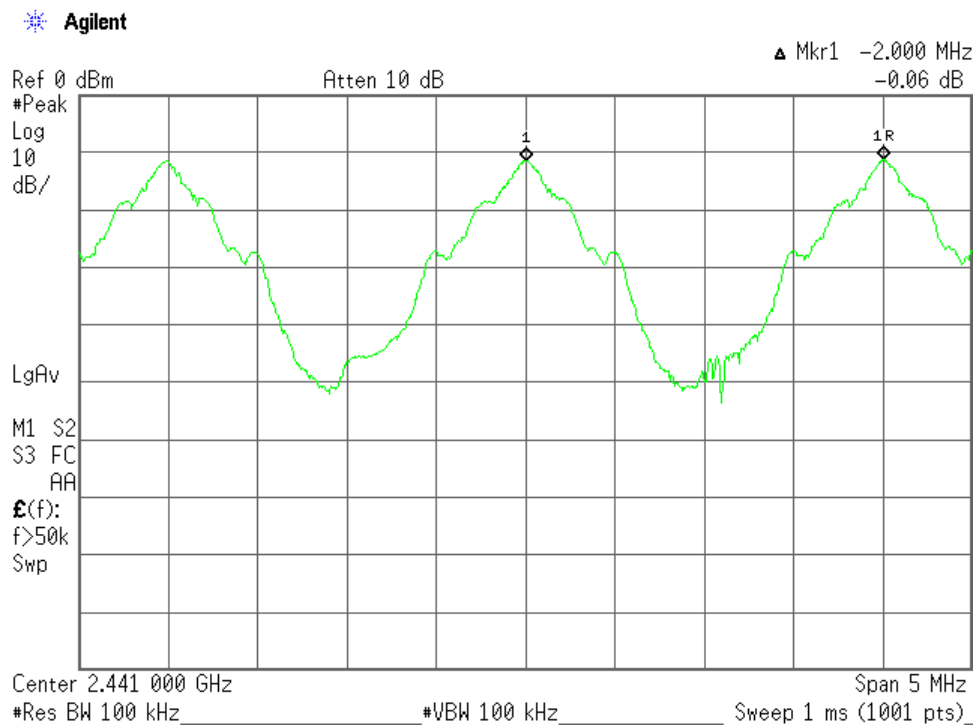
A.1 Channel Separation

Mode of EUT	Channel Separation (MHz)
Hopping	1.002
Inquiry	2.000

Mode of EUT : Hopping



Mode of EUT : Inquiry



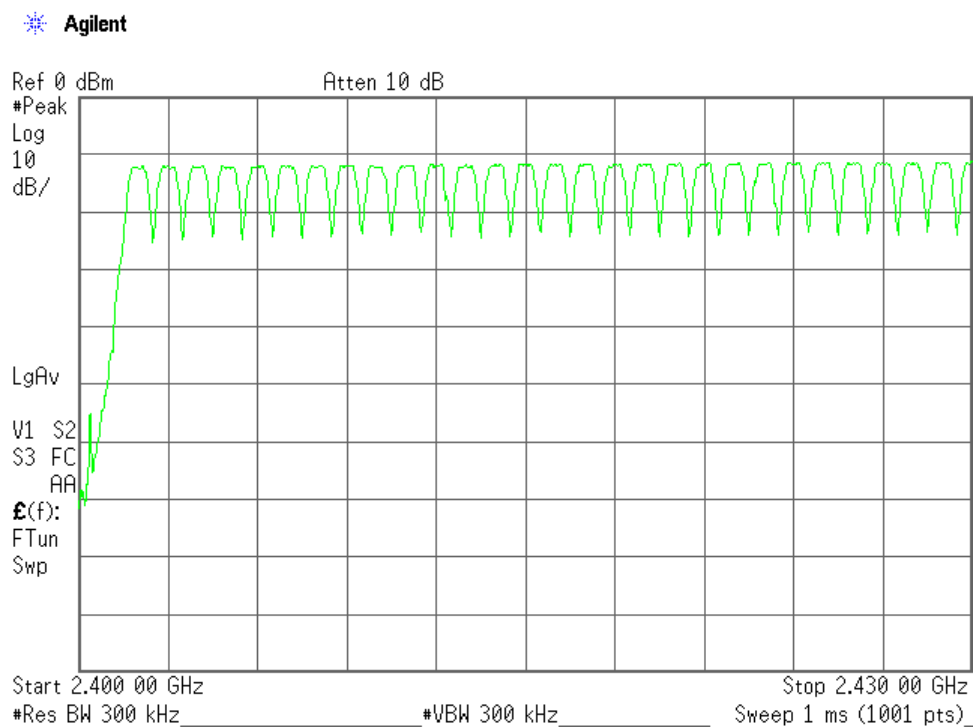
A.2 Minimum Hopping Channel

Test Date : July 22, 2011

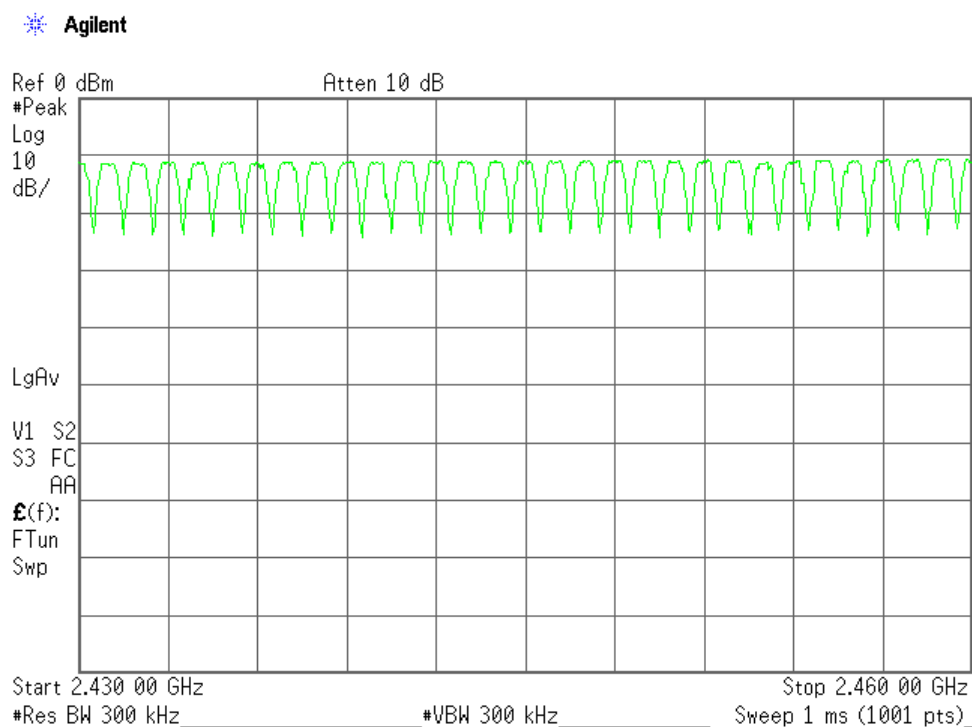
Temp.:28°C, Humi:66%

Mode of EUT	Minimum Hopping Channel
Hopping	79
Inquiry	32

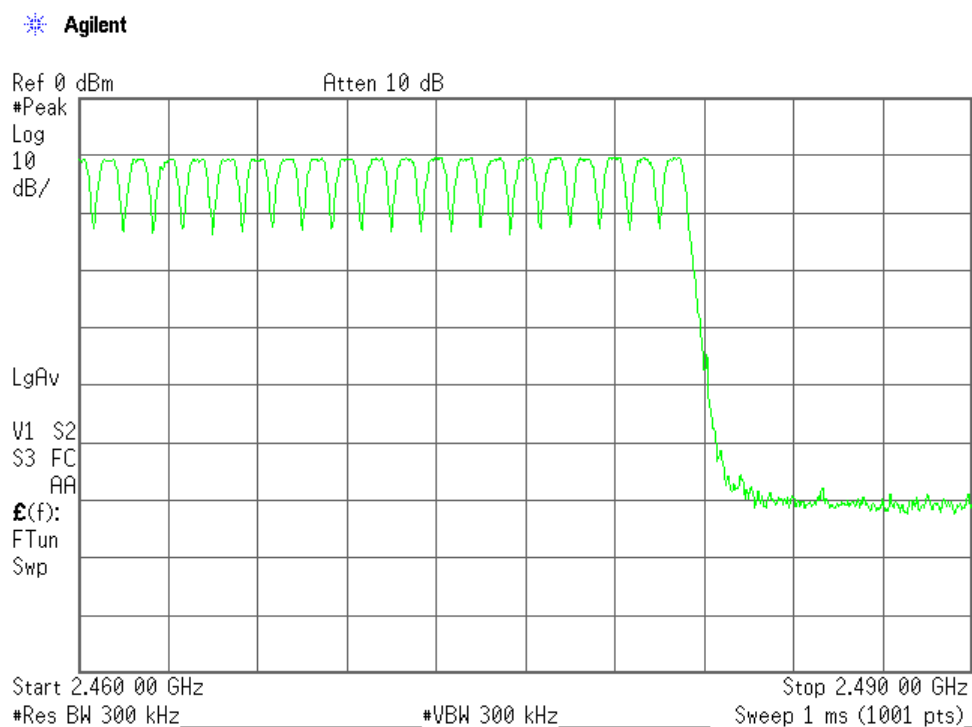
Mode of EUT : Hopping(1/3)



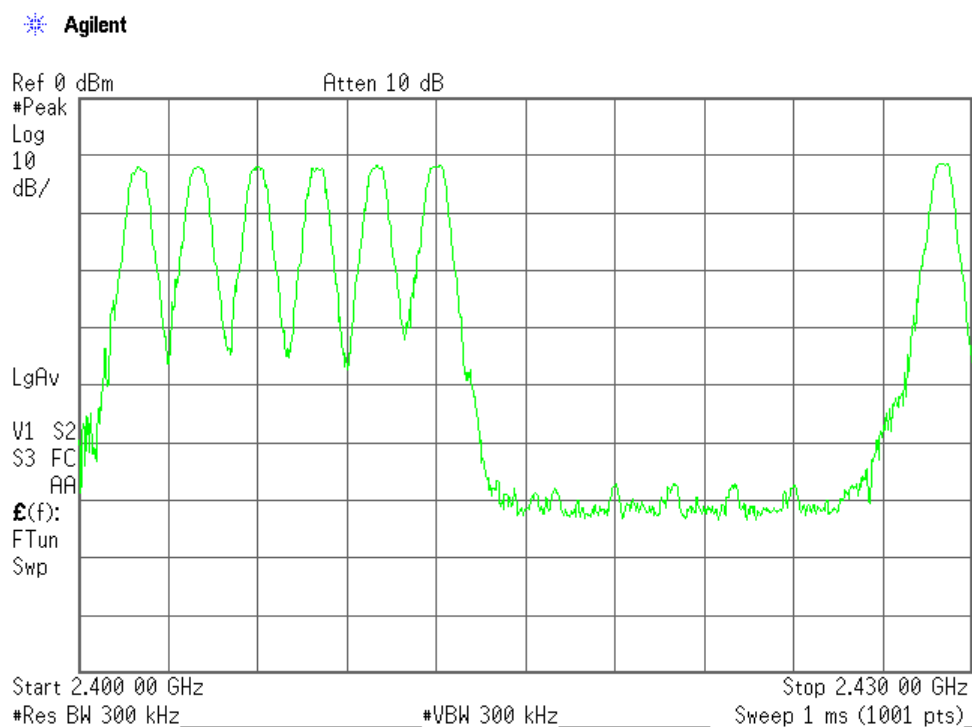
Mode of EUT : Hopping(2/3)



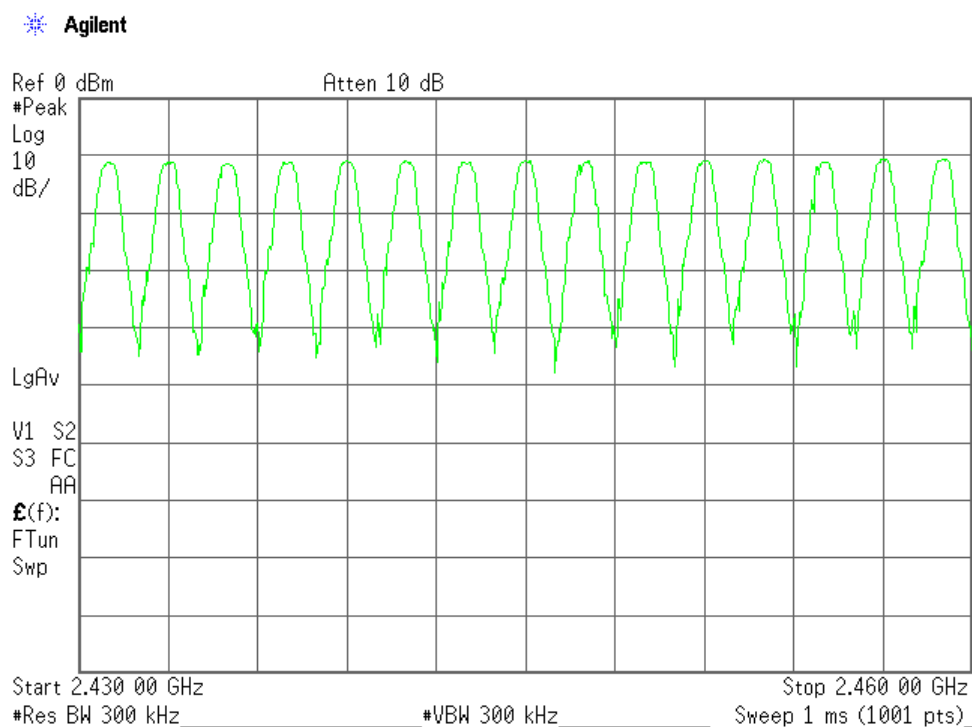
Mode of EUT : Hopping(3/3)



Mode of EUT : Inquiry(1/3)

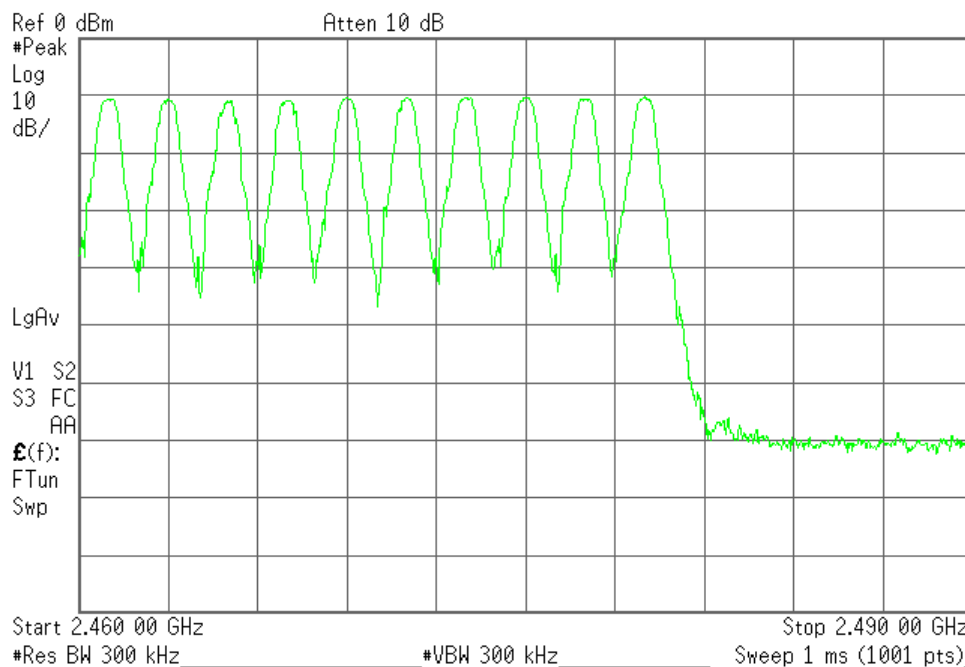


Mode of EUT : Inquiry(2/3)



Mode of EUT : Inquiry(3/3)

 Agilent



A.3 Occupied BandwidthTest Date : July 22, 2011Temp.:28°C, Humi:66%

The resolution bandwidth was set to about 1% of emission bandwidth, -20dBc display line was placed on the screen (or 99% bandwidth), the occupied bandwidth is the delta frequency between the two points where the display line intersects the signal trace.

1)Packet Setting : DH5(Modulation type : GFSK)

Channel	Frequency (MHz)	99% Bandwidth (kHz)	-20dBc Bandwidth (kHz)
00	2402.0	879.7	925.0
39	2441.0	880.0	924.3
78	2480.0	879.5	924.1

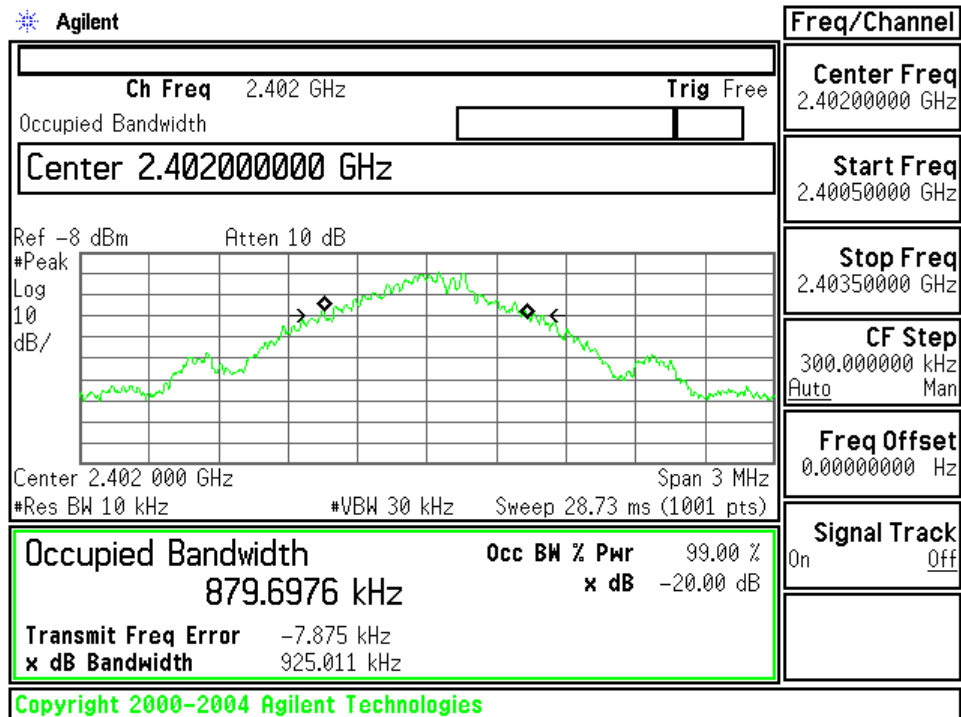
2)Packet Setting : 2DH5(Modulation type : pi/4-DQPSK)

Channel	Frequency (MHz)	99% Bandwidth (kHz)	-20dBc Bandwidth (kHz)
00	2402.0	1171.9	1313.0
39	2441.0	1171.5	1314.0
78	2480.0	1170.5	1312.0

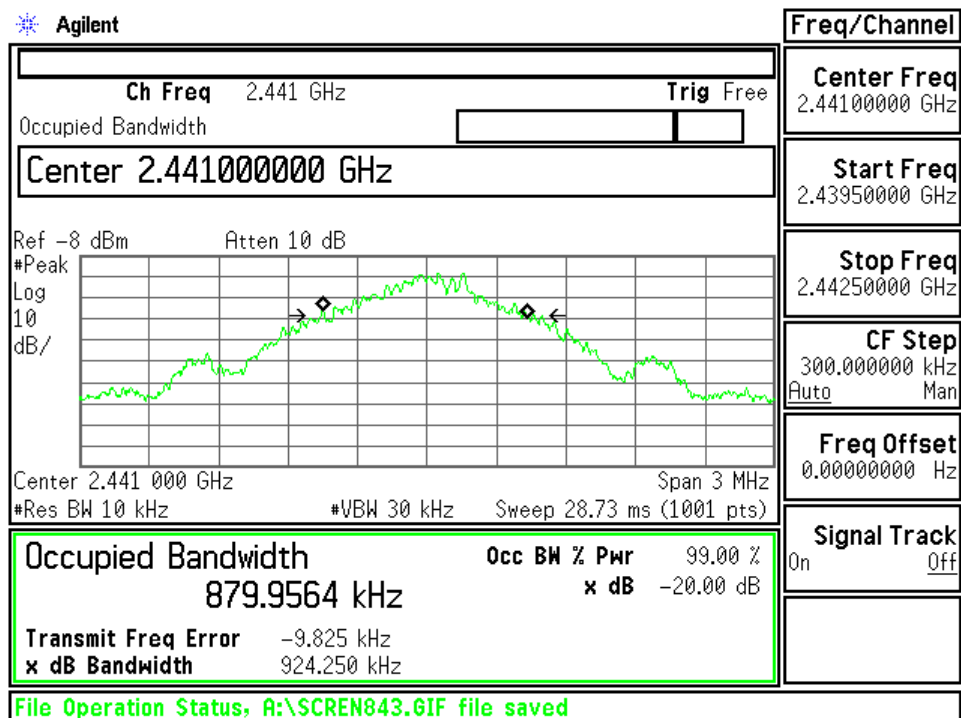
3)Packet Setting : 3 DH5(Modulation type : 8DPSK)

Channel	Frequency (MHz)	99% Bandwidth (kHz)	-20dBc Bandwidth (kHz)
00	2402.0	1175.9	1258.0
39	2441.0	1173.6	1257.0
78	2480.0	1174.2	1257.0

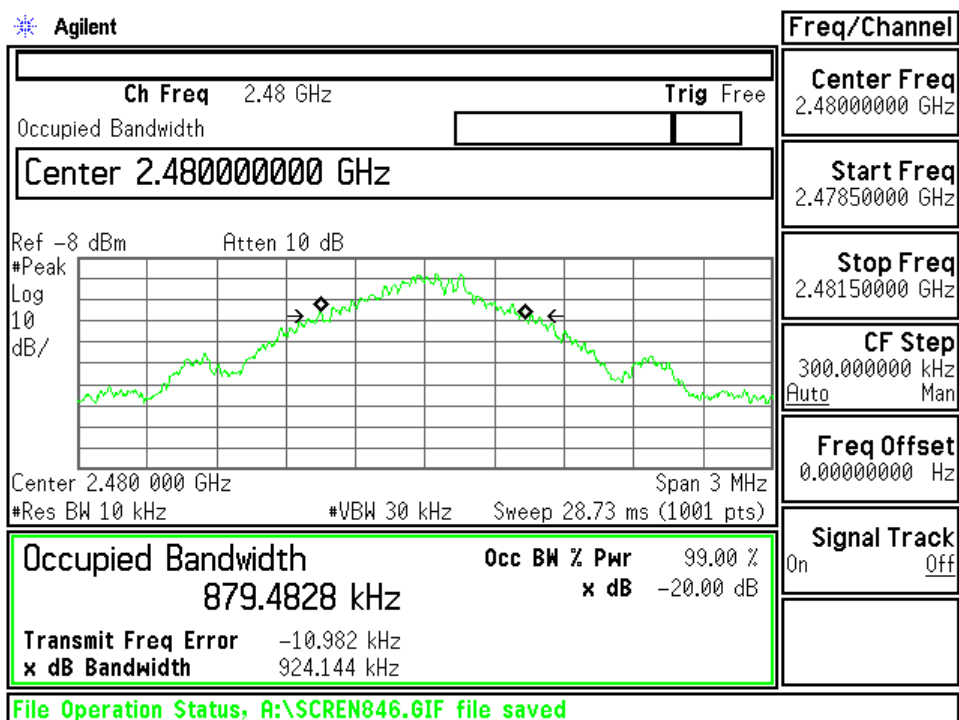
1)Packet Setting : DH5(Modulation type : GFSK)
Low Channel



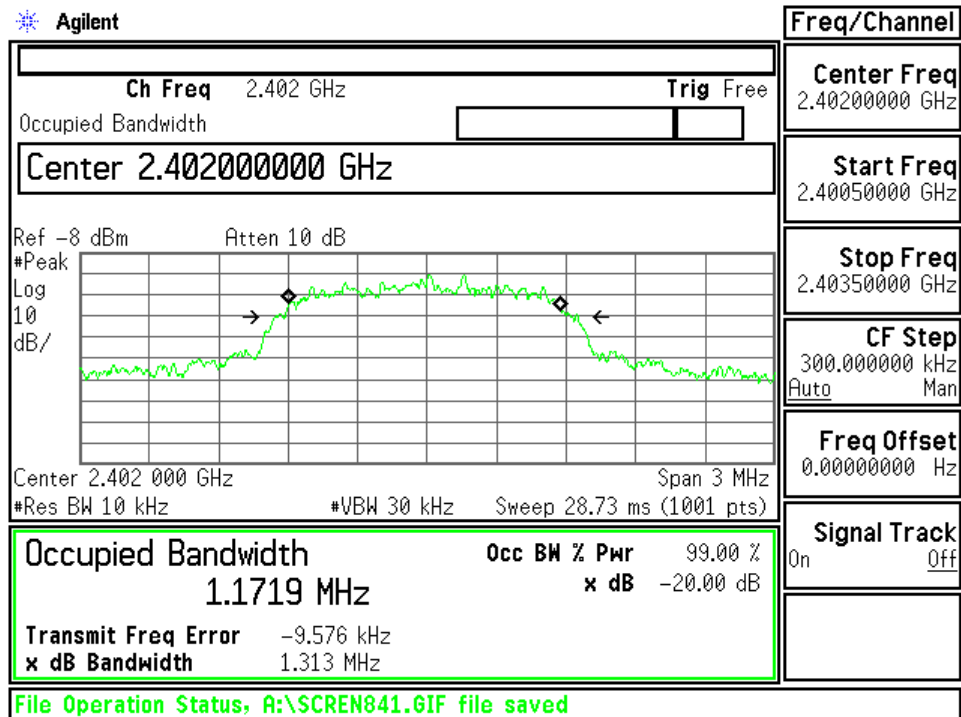
Middle Channel



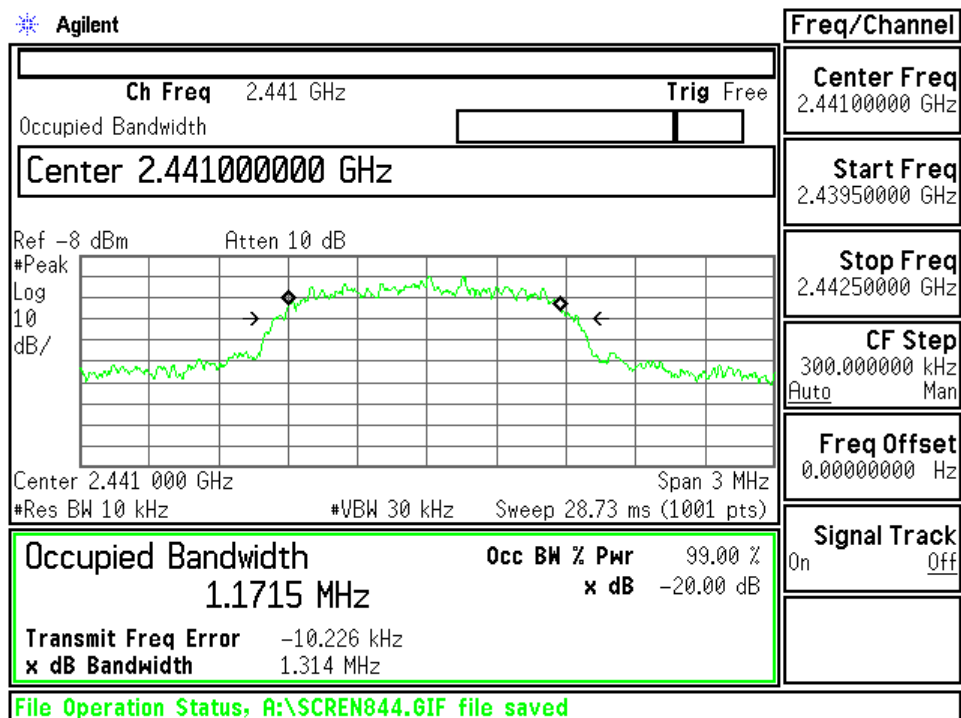
High Channel



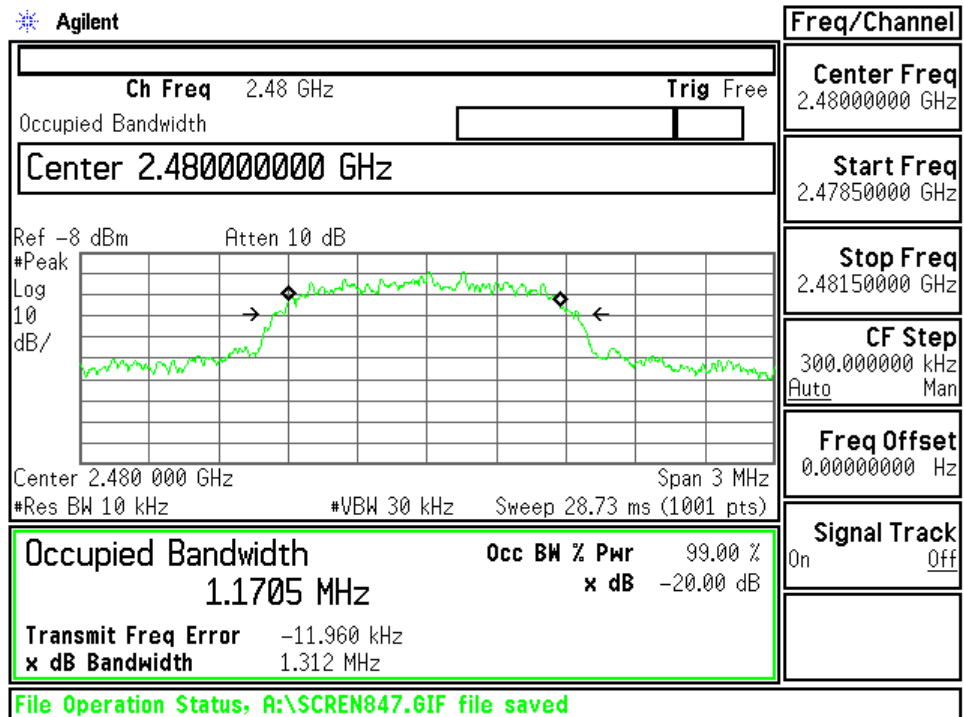
2)Packet Setting : 2DH5(Modulation type : pi/4-DQPSK)
Low Channel



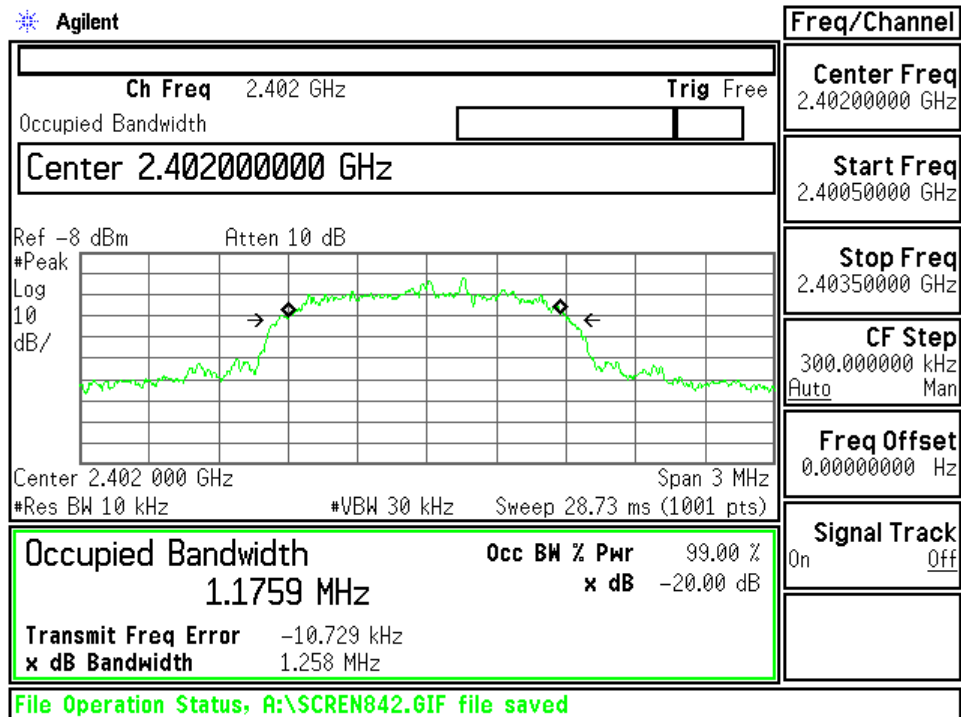
Middle Channel



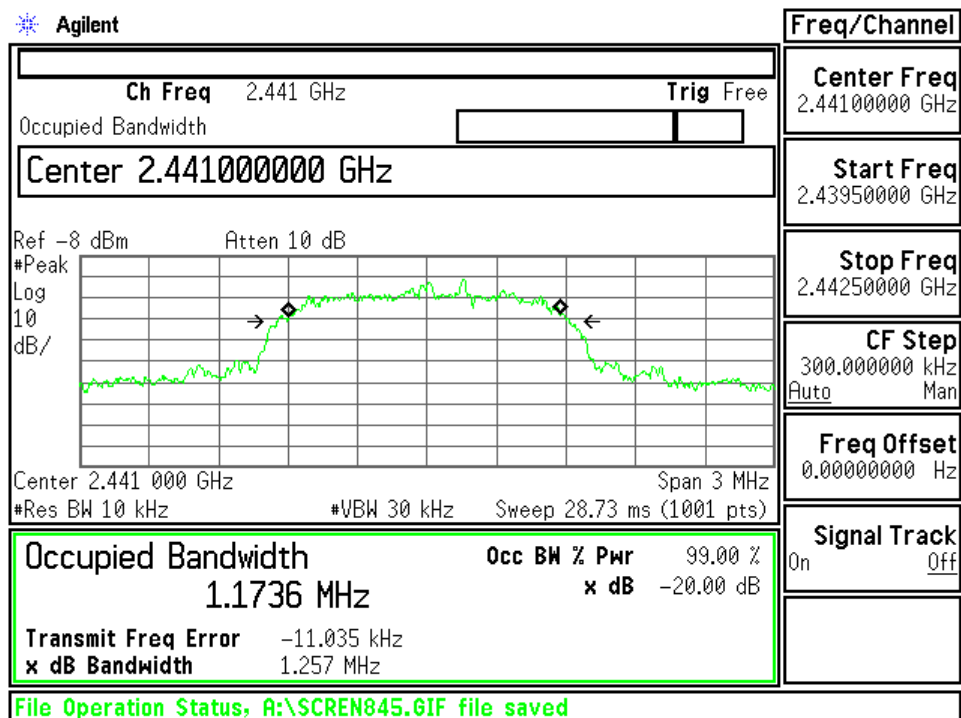
High Channel



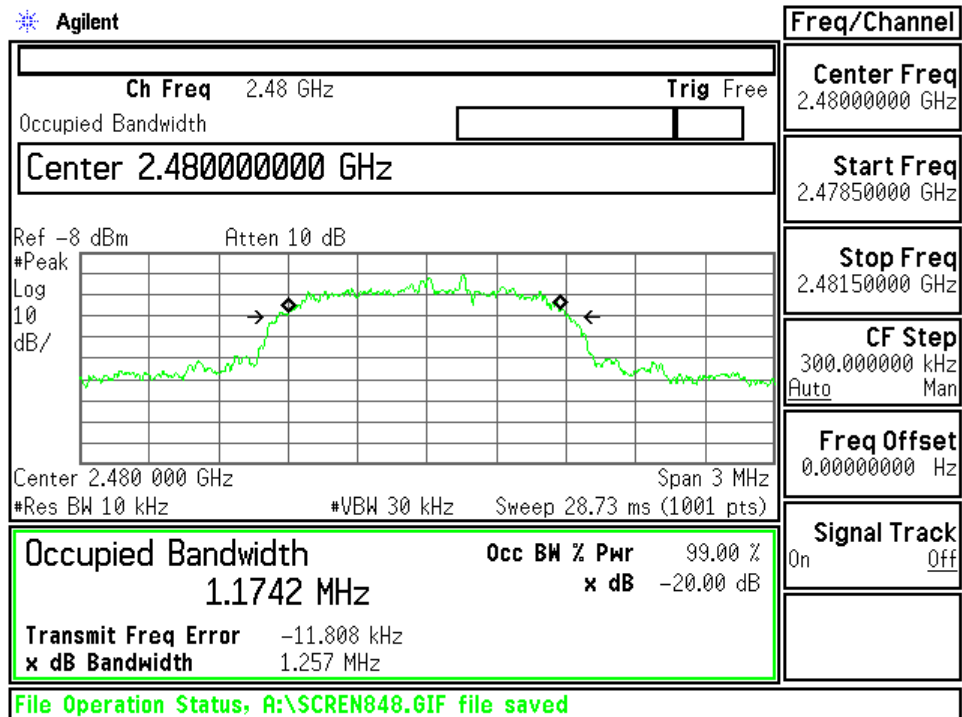
3)Packet Setting : 3 DH5(Modulation type : 8DPSK)
Low Channel



Middle Channel



High Channel



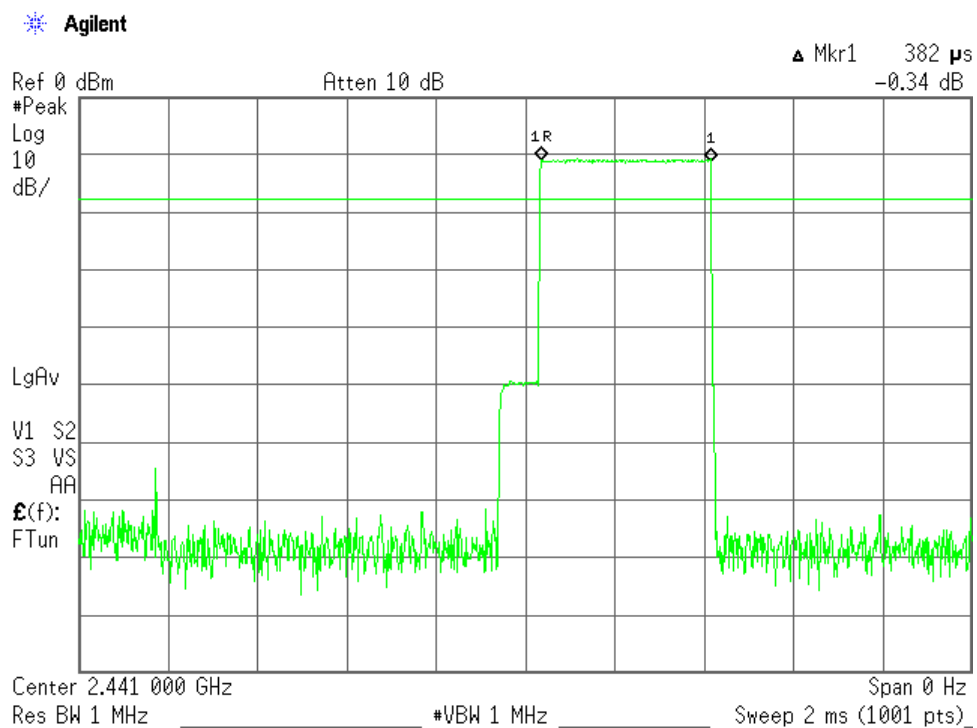
A.4 Dwell Time

Test Date : July 22, 2011

Temp.:28°C, Humi:66%

Mode of EUT	Dwell Time (msec)
DH1	122.2
DH3	262.4
DH5	308.1
Inquiry	64.5

DH1(Modulation type : GFSK)

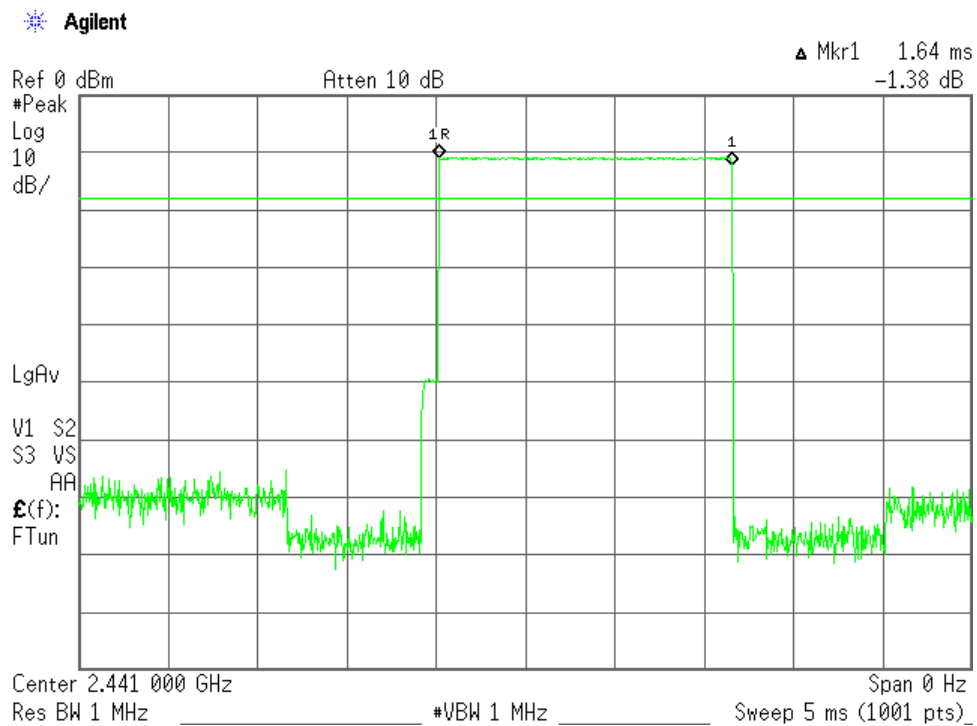


Note : The system makes worst case 1600 hops per second or 1 time slot has a length of 625 μs with 79 channels. A DH1 Packet need 1 time slot for transmitting and 1 time slot for receiving. Then the system makes worst case 800 hops per second with 79 channels. So the system has each channel 10.1266 times per second and so for 31.6 seconds the system have 320.0 times of appearance.

Each tx-time per appearance is 0.382 ms.

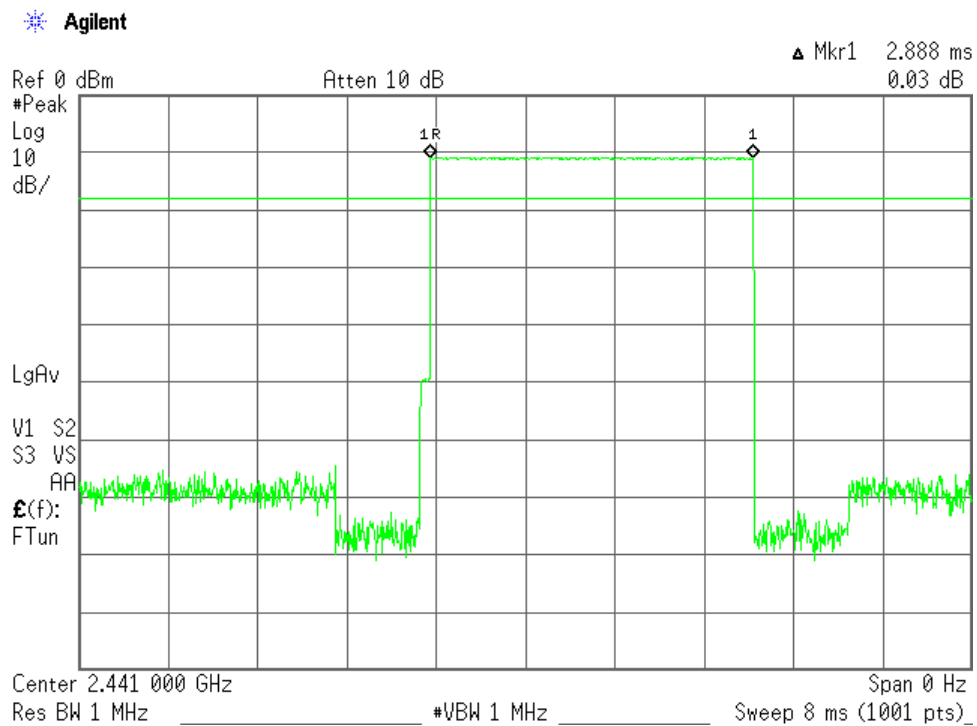
Dwell time = 320.0 * 0.382 = 122.2 ms

DH3(Modulation type : GFSK)



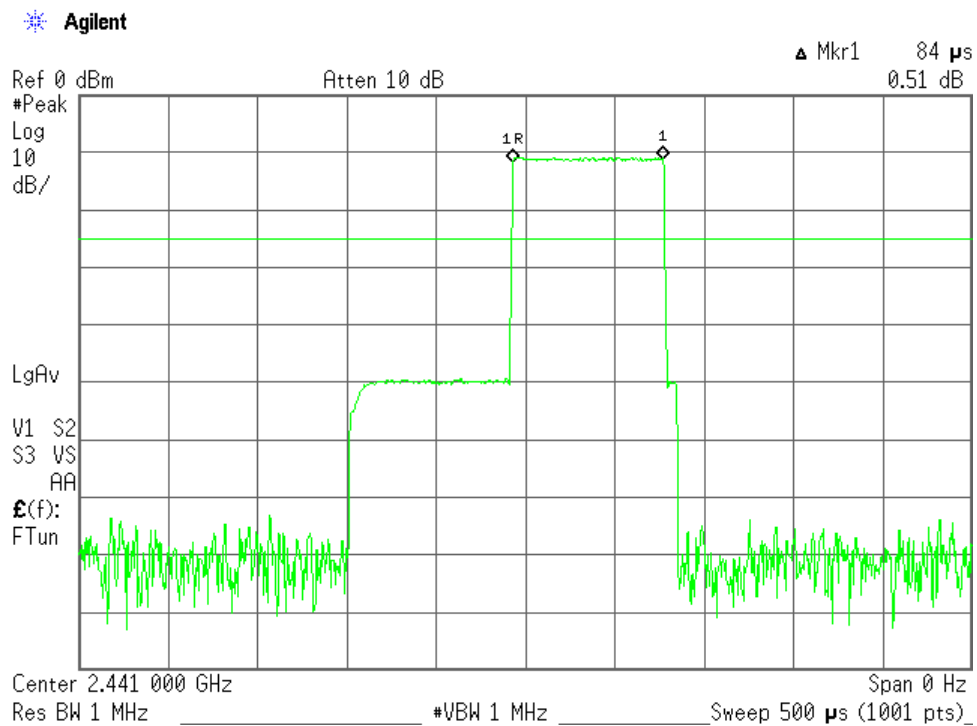
Note : A DH3 Packet need 3 time slot for transmitting and 1 time slot for receiving. Then the system makes worst case 400 hops per second with 79 channels. So the system have each channel 5.063 times per second and so for 31.6 seconds the system have 160.0 times of appearance. Each tx-time per appearance is 1.640 ms.
Dwell time = 160.0 * 1.640 = 262.4 ms

DH5(Modulation type : GFSK)



Note : A DH5 Packet need 5 time slot for transmitting and 1 time slot for receiving. Then the system makes worst case 266.667 hops per second with 79 channels. So the system have each channel 3.3755 times per second and so for 31.6 seconds the system have 106.7 times of appearance. Each tx-time per appearance is 2.888 ms.
Dwell time = 106.7 * 2.888 = 308.1 ms

Inquiry



Note : The system have 32 hopping channel in Inquiry mode.
 The time period = $32 * 0.4 = 12.8$ seconds
 In maximum case the bluetooth system have three blocks of 2560 ms in 12.8 s period. One block has 256 burst at each hopping channel.
 Each tx-time per appearance is 0.084 ms.
 Dwell time = $0.084 * 256 * 3 = 64.5$ ms

A.5 Peak Output Power(Conduction)

1)DH5(Modulation type : GFSK)

Test Date: July 22, 2011
Temp.: 28 °C, Humi: 66 %

Transmitting Frequency		Correction Factor	Meter Reading	Conducted Peak Output Power		Limits	Margin
CH	[MHz]	[dB]	[dBm]	[dBm]	[mW]	[dBm]	[dB]
00	2402	9.88	-11.74	-1.86	0.65	20.97	+22.83
39	2441	9.88	-10.67	-0.79	0.83	20.97	+21.76
78	2480	9.88	-10.04	-0.16	0.96	20.97	+21.13

Calculated result at 2480.000 MHz, as the worst point shown on underline:

Correction Factor	=	9.88 dB
+) Meter Reading	=	-10.04 dBm
Result	=	-0.16 dBm = 0.96 mW

Minimum Margin: 20.97 - -0.16 = 21.13 (dB)

NOTES

- The correction factor shows the attenuation pad loss including the short, low loss cable or adapter.
- Setting of measuring instrument(s) :

Detector Function	Video B.W.
Peak	Off

2)2DH5(Modulation type : pi/4-DQPSK)

Test Date: July 22, 2011
Temp.: 28 °C, Humi: 66 %

Transmitting Frequency		Correction Factor	Meter Reading	Conducted Peak Output Power		Limits	Margin
CH	[MHz]	[dB]	[dBm]	[dBm]	[mW]	[dBm]	[dB]
00	2402	9.88	-9.05	0.83	1.21	20.97	+20.14
39	2441	9.88	-7.85	2.03	1.60	20.97	+18.94
78	2480	9.88	-7.37	2.51	1.78	20.97	+18.46

Calculated result at 2480.000 MHz, as the worst point shown on underline:

Correction Factor	=	9.88 dB
+) Meter Reading	=	-7.37 dBm
Result	=	2.51 dBm = 1.78 mW

Minimum Margin: 20.97 - 2.51 = 18.46 (dB)

NOTES

- The correction factor shows the attenuation pad loss including the short, low loss cable or adapter.
- Setting of measuring instrument(s) :

Detector Function	Video B.W.
Peak	Off

3)3DH5(Modulation type : 8DPSK)

Test Date: July 22, 2011
Temp.: 28 °C, Humi: 66 %

Transmitting Frequency		Correction Factor	Meter Reading	Conducted Peak Output Power		Limits	Margin
CH	[MHz]	[dB]	[dBm]	[dBm]	[mW]	[dBm]	[dB]
00	2402	9.88	-11.30	-1.42	0.72	20.97	+22.39
39	2441	9.88	-10.34	-0.46	0.90	20.97	+21.43
78	2480	9.88	-9.64	0.24	1.06	20.97	+20.73

Calculated result at 2480.000 MHz, as the worst point shown on underline:

Correction Factor	=	9.88 dB
+) Meter Reading	=	-9.64 dBm
Result	=	0.24 dBm = 1.06 mW

Minimum Margin: 20.97 - 0.24 = 20.73 (dB)

NOTES

- The correction factor shows the attenuation pad loss including the short, low loss cable or adapter.
- Setting of measuring instrument(s) :

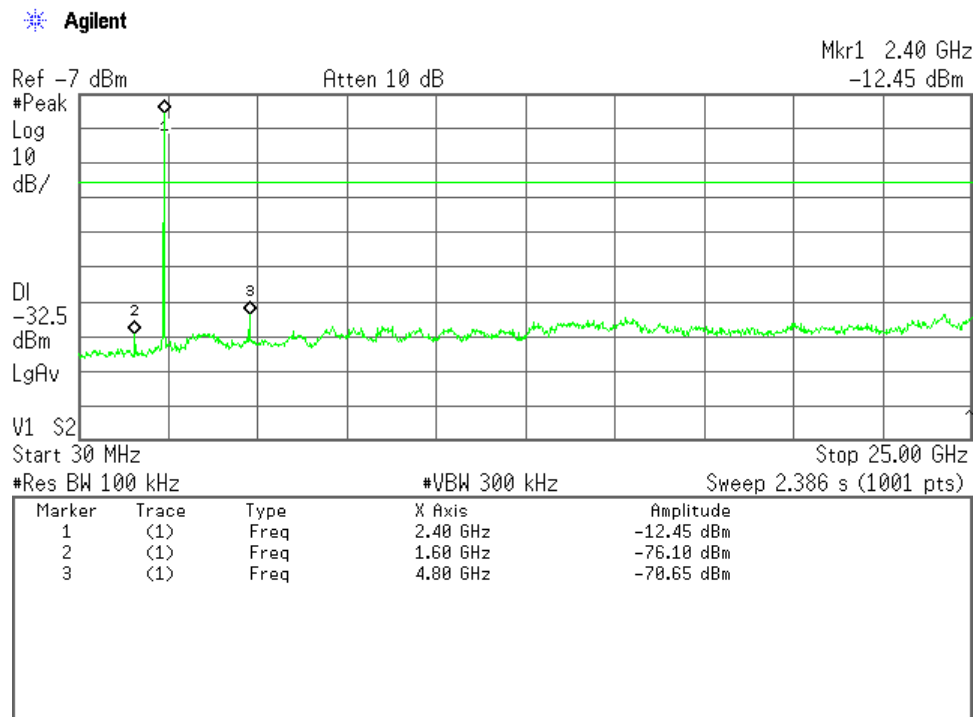
Detector Function	Video B.W.
Peak	Off

A.6 Spurious Emission(Conduction)

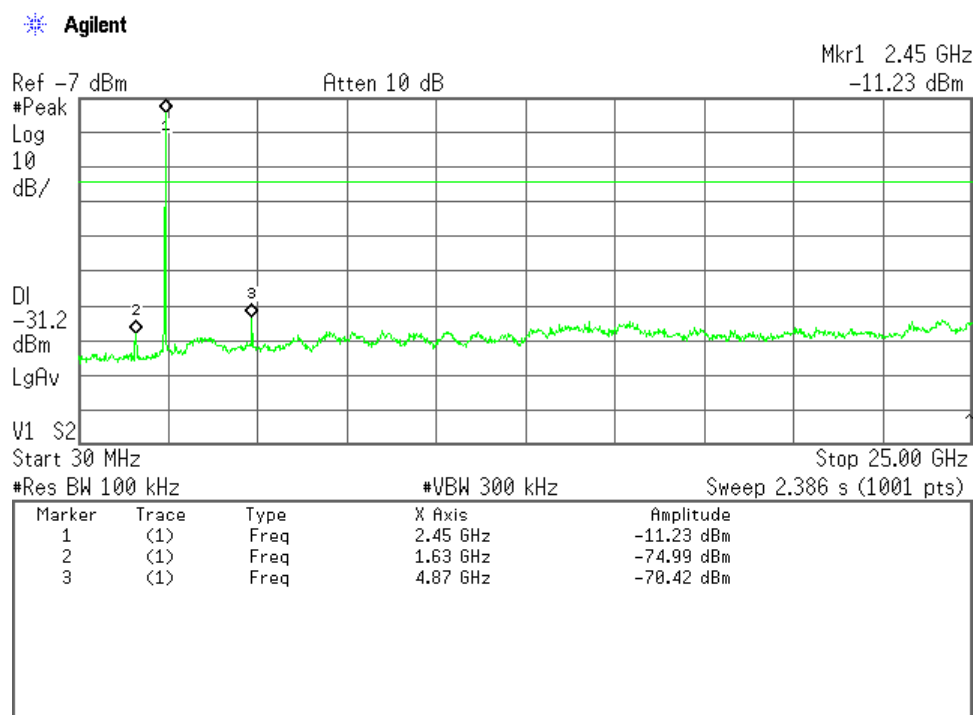
Test Date : July 22, 2011

Temp.:28°C, Humi:66%

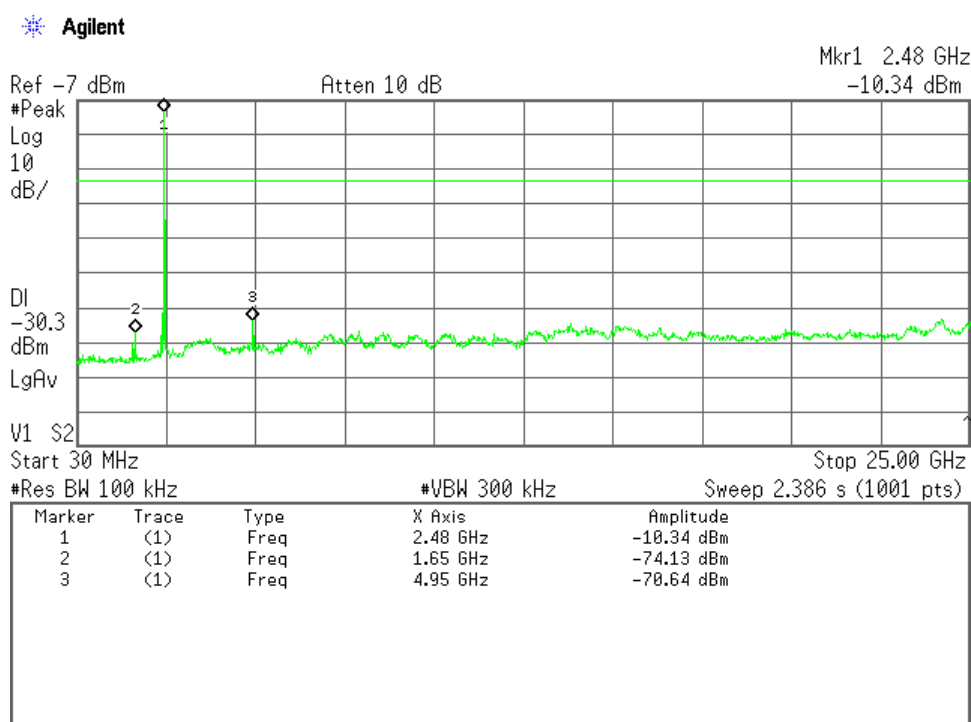
Low Channel



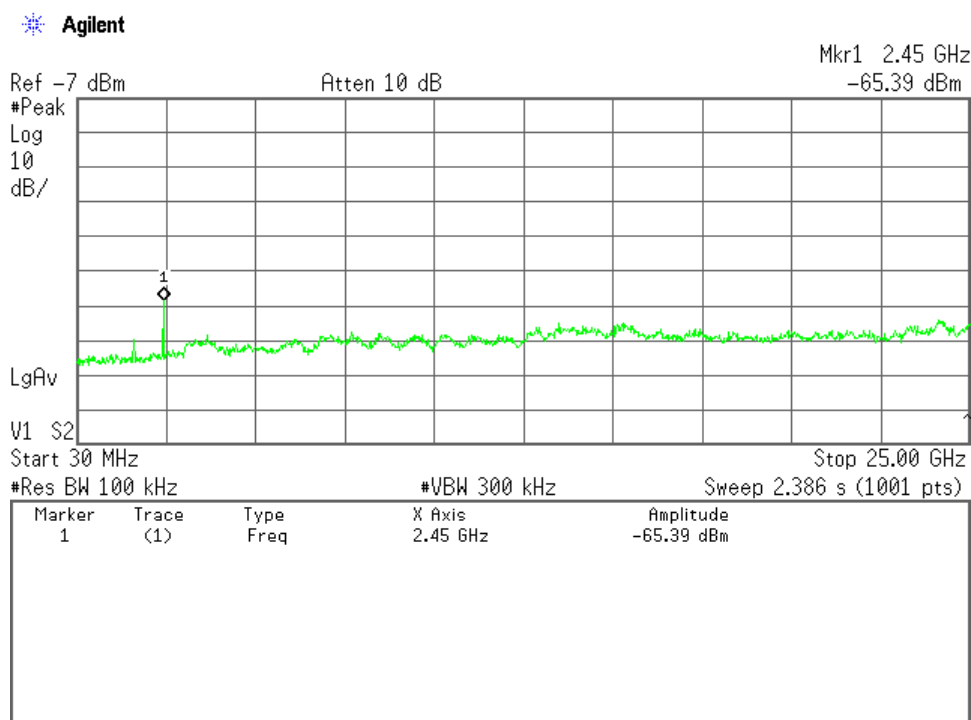
Middle Channel



High Channel

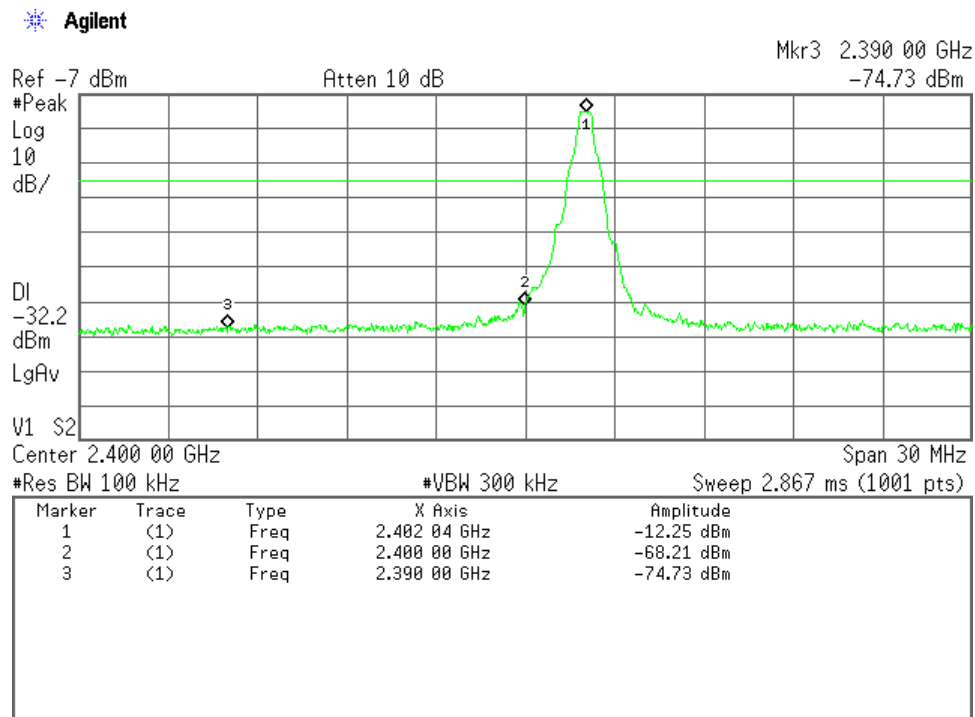


Receiving(Middle Channel)

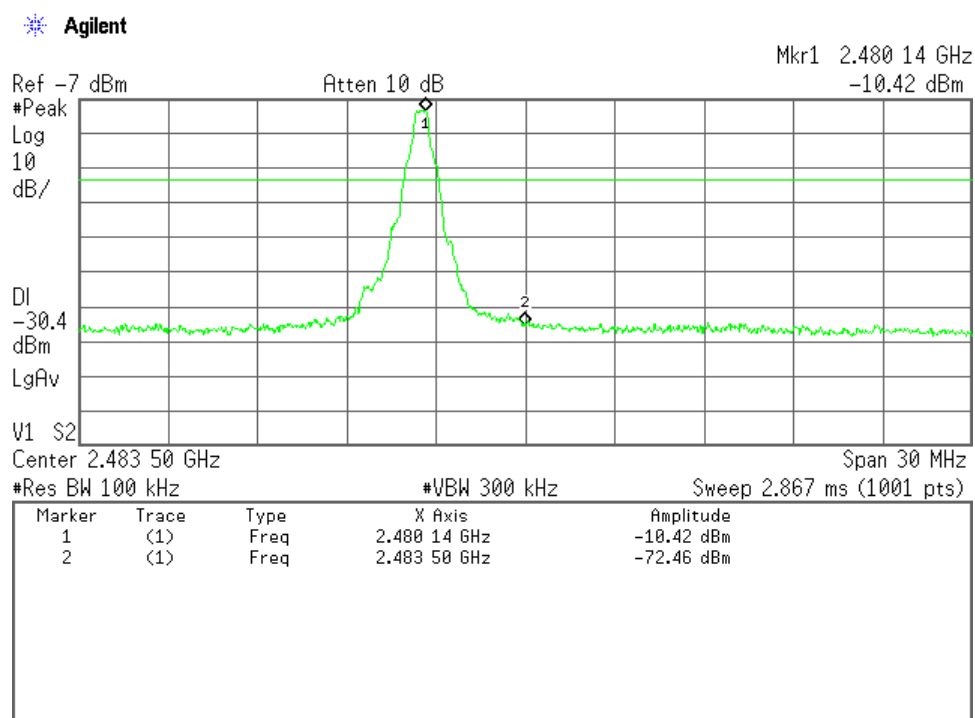


Band-Edge Emission

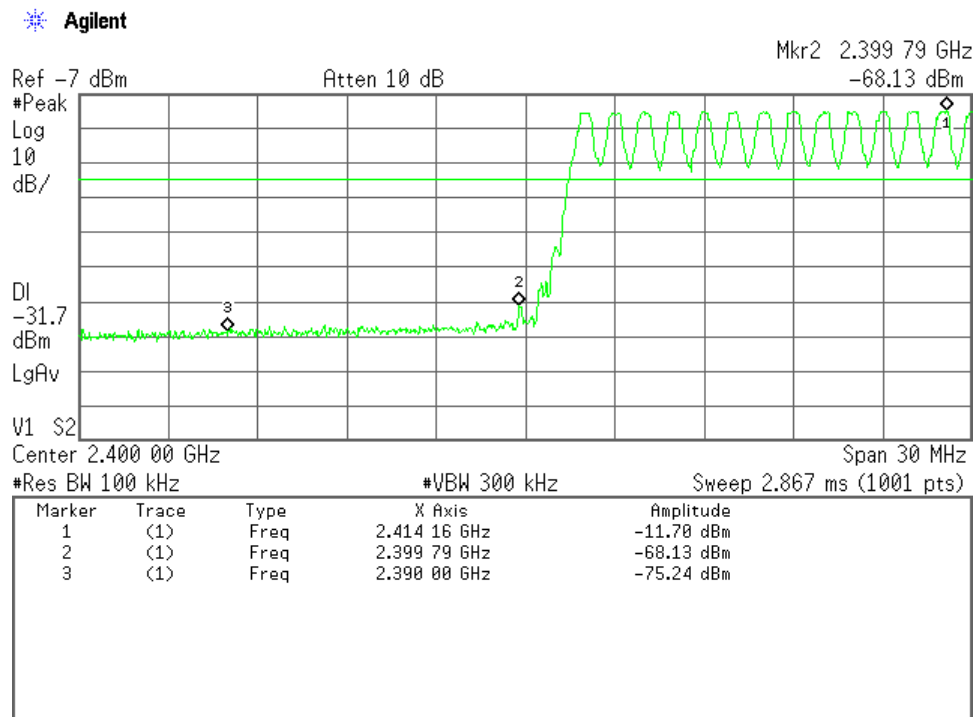
Low Channel(Hopping off), Band-Edge Emission



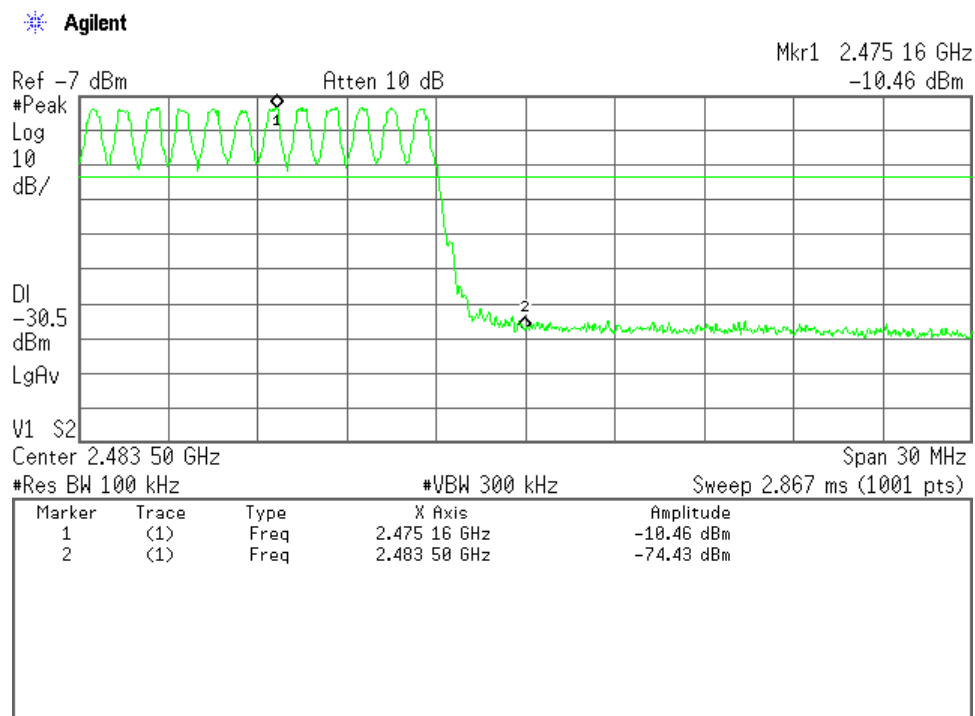
High Channel(Hopping off), Band-Edge Emission



Low Channel(Hopping on), Band-Edge Emission



High Channel(Hopping on), Band-Edge Emission

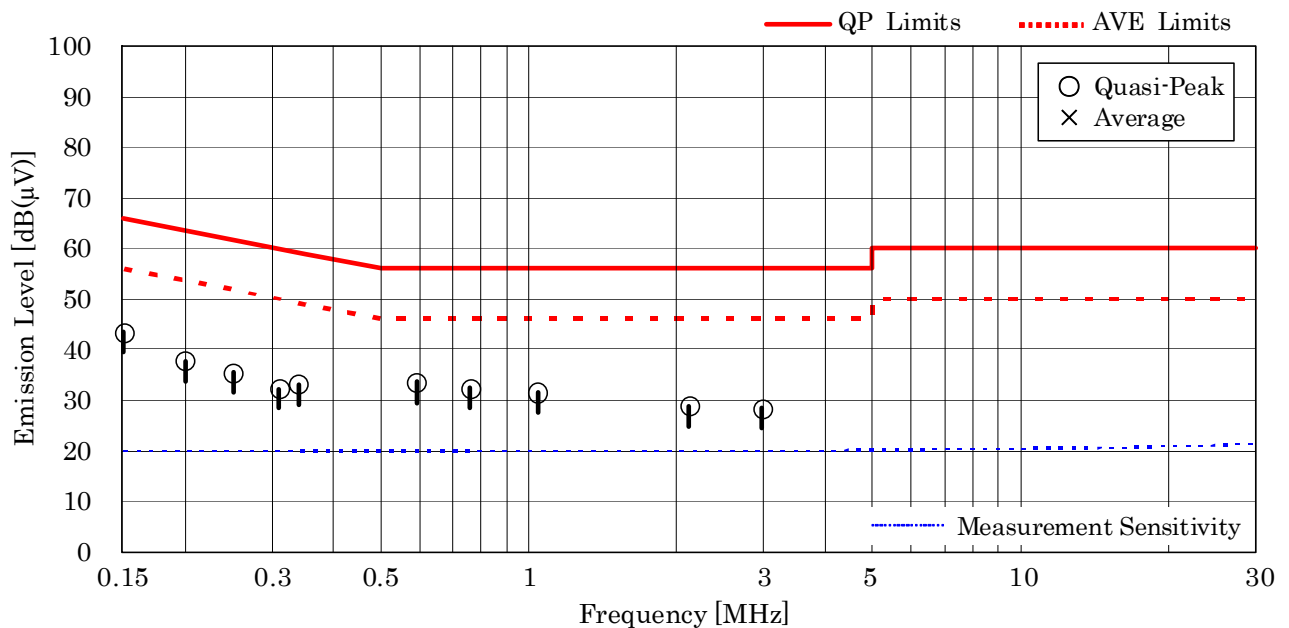


A.7 AC Powerline Conducted Emission

Test Date: August 17, 2011

Temp.: 24 °C, Humi.: 66 %

Frequency [MHz]	Corr. Factor [dB]	Meter Readings [dB(μV)]				Limits [dB(μV)]		Results [dB(μV)]		Margin [dB]	Remarks
		VA		VB		QP	AVE	QP	AVE		
		QP	AVE	QP	AVE	QP	AVE	QP	AVE		
0.15	10.0	33.4	--	31.4	--	66.0	56.0	43.4	--	+22.6	-
0.20	10.0	27.8	--	27.1	--	63.6	53.6	37.8	--	+25.8	-
0.25	9.9	25.5	--	23.8	--	61.8	51.8	35.4	--	+26.4	-
0.31	9.9	22.4	--	19.9	--	60.0	50.0	32.3	--	+27.7	-
0.34	9.9	23.2	--	19.8	--	59.2	49.2	33.1	--	+26.1	-
0.59	9.9	23.6	--	17.2	--	56.0	46.0	33.5	--	+22.5	-
0.76	9.9	22.5	--	17.9	--	56.0	46.0	32.4	--	+23.6	-
1.04	10.0	21.5	--	16.8	--	56.0	46.0	31.5	--	+24.5	-
2.12	10.0	18.8	--	14.0	--	56.0	46.0	28.8	--	+27.2	-
2.98	10.1	18.2	--	13.9	--	56.0	46.0	28.3	--	+27.7	-



NOTES

- The spectrum was checked from 0.15 MHz to 30 MHz.
- The correction factor includes the AMN insertion loss and the cable loss.
- The symbol of "<" means "or less".
- The symbol of ">" means "more than".
- The symbol of "--" means "not applicable".
- Calculated result at 0.59 MHz, as the worst point shown on underline:
Correction Factor + Meter Reading = 9.9 + 23.6 = 33.5 dB(μV)
- QP : Quasi-Peak Detector / AVE : Average Detector
- Test receiver setting(s) : CISPR QP 9 kHz / Average 9 kHz

A.8 Field Strength of Spurious Radiation

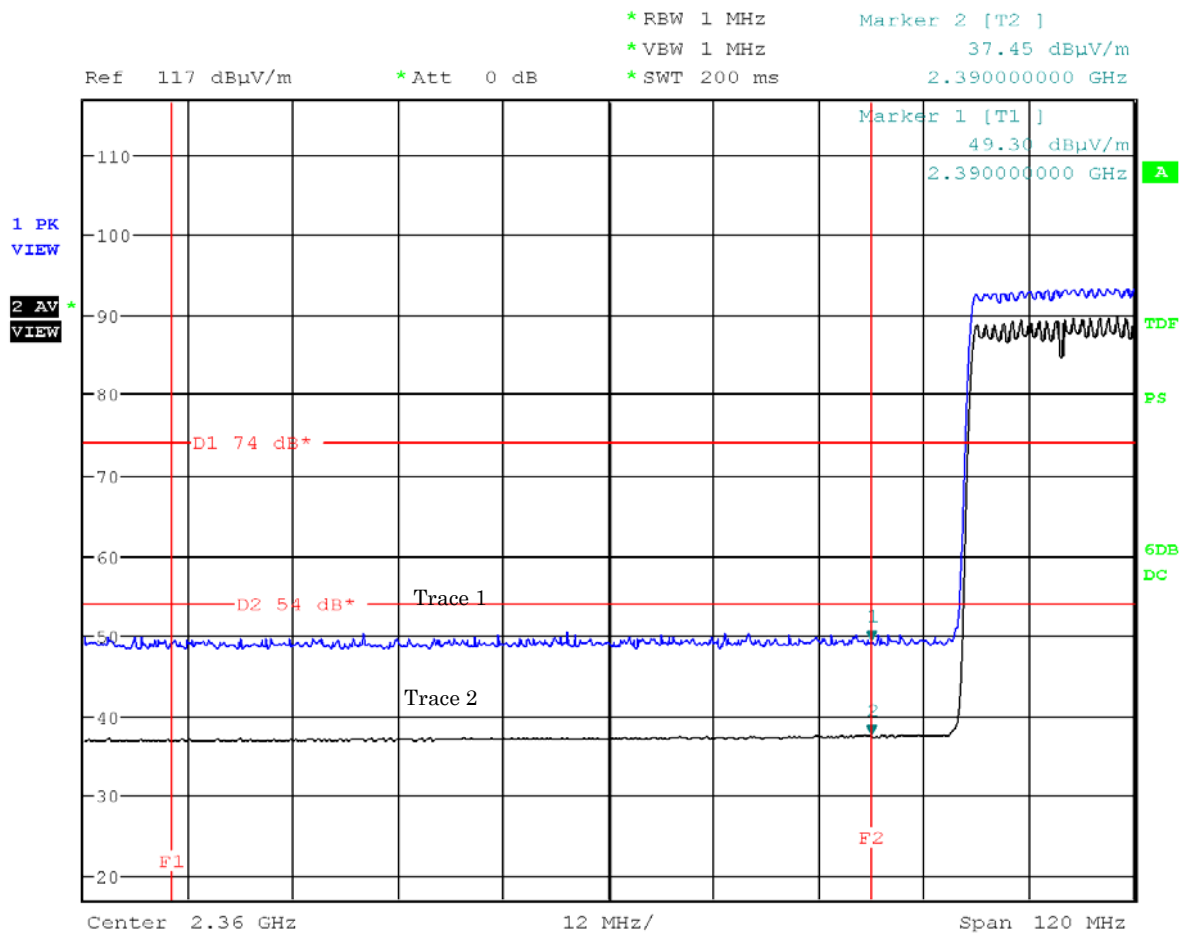
A.8.1 Band-edge Compliance

Test Date : August 17, 2011

Temp.:25°C, Humi:61%

Mode of EUT : Hopping

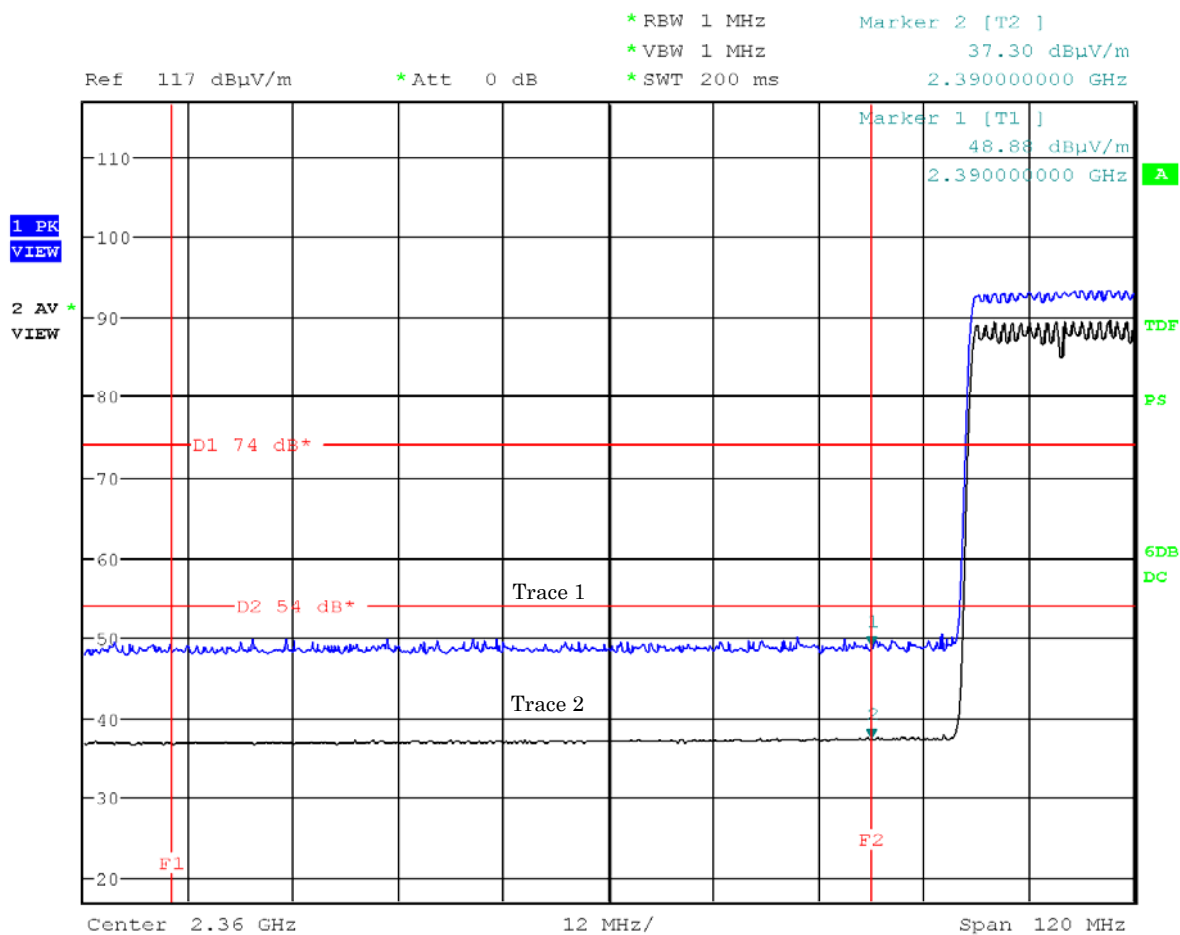
Antenna Polarization : Horizontal



Note: The trace 1 is Peak detection. The trace 2 is Average detection.

Mode of EUT : Hopping

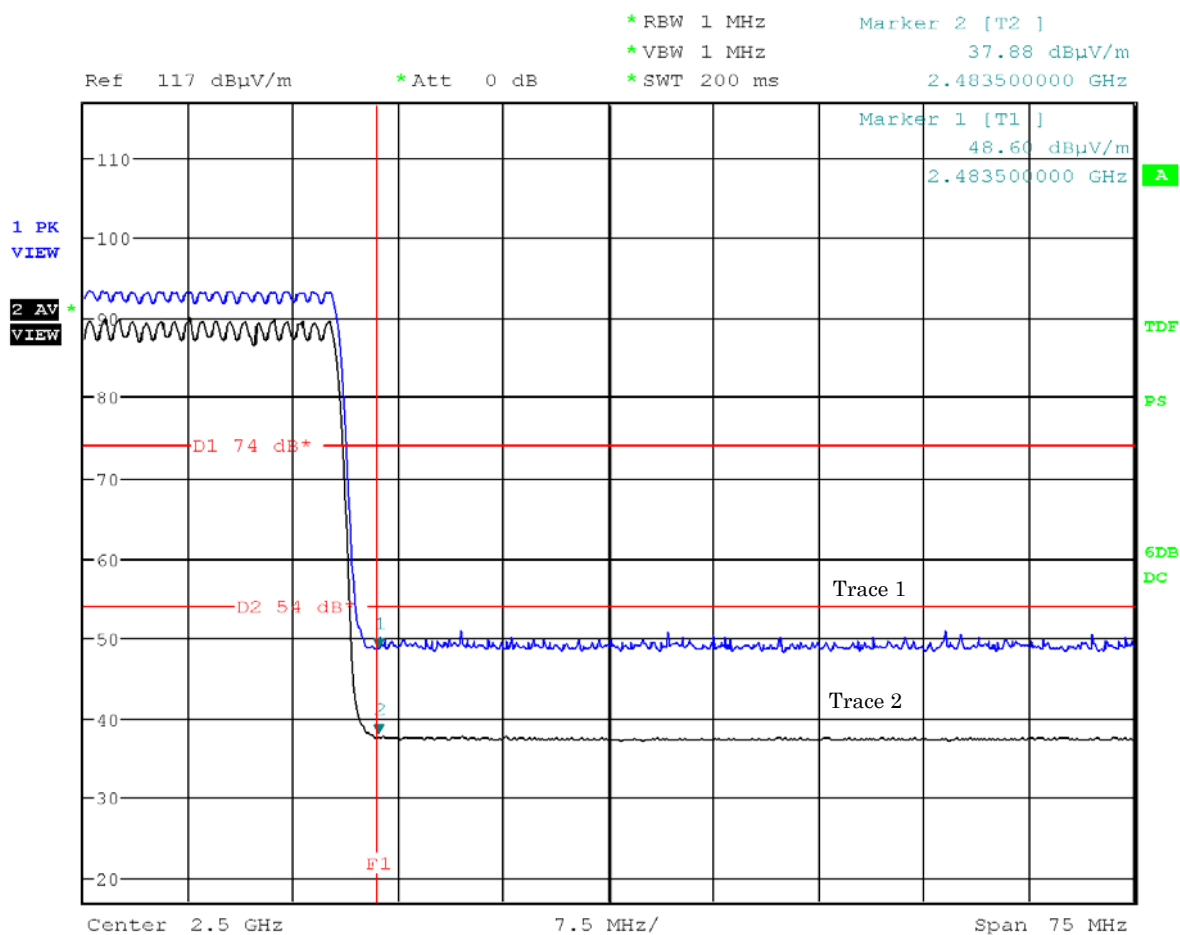
Antenna Polarization : Vertical



Note: The trace 1 is Peak detection. The trace 2 is Average detection.

Mode of EUT : Hopping

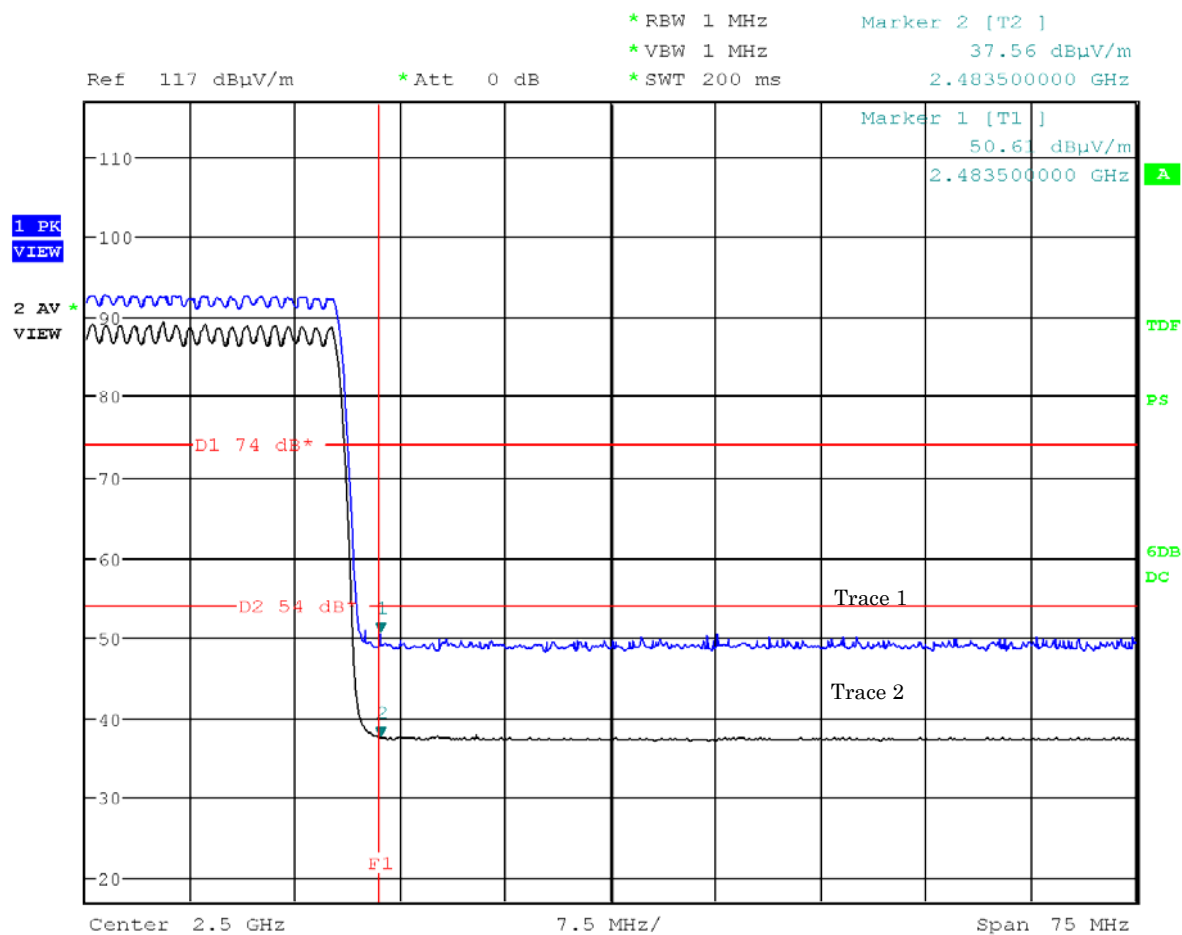
Antenna Polarization : Horizontal



Note: The trace 1 is Peak detection. The trace 2 is Average detection.

Mode of EUT : Hopping

Antenna Polarization : Vertical



Note: The trace 1 is Peak detection. The trace 2 is Average detection.

A.8.2 Other Spurious Emission

A.8.2.1 Other Spurious Emission(9kHz – 30MHz)

Test Date : August 17, 2011

Temp.:25°C, Humi:61%

Mode of EUT : All modes have been investigated and the worst case mode for channel (39ch: 2441MHz) has been listed.

Results : No spurious emissions in the range 20dB below the limit.

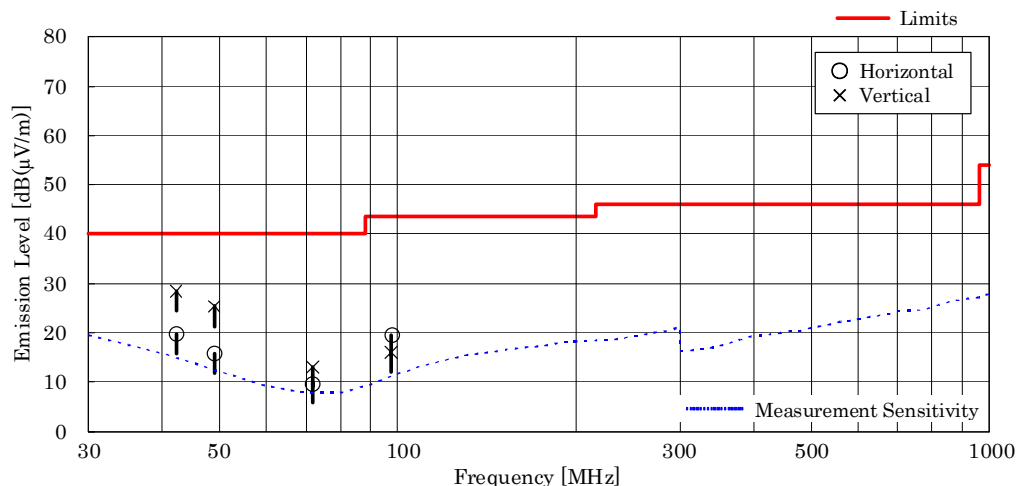
A.8.2.2 Other Spurious Emission(30MHz – 1000MHz)

Mode of EUT : All modes have been investigated and the worst case mode for channel (39ch: 2441MHz) has been listed.

Test Date: August 17, 2011

Temp: 25 °C, Humi: 61 %

Frequency [MHz]	Antenna Factor [dB(1/m)]	Cable Loss [dB]	Meter Readings [dB(μV)]		Limits [dB(μV/m)]	Results [dB(μV/m)]		Margin [dB]	Remarks
			Hori.	Vert.		Hori.	Vert.		
42.2	14.1	0.9	4.8	13.4	40.0	19.8	28.4	+11.6	-
48.9	11.5	1.0	3.3	12.8	40.0	15.8	25.3	+14.7	-
71.8	6.6	1.2	1.9	5.3	40.0	9.7	13.1	+26.9	-
97.5	9.6	1.4	8.6	5.0	43.5	19.6	16.0	+23.9	-



NOTES

1. Test Distance : 3 m
2. The spectrum was checked from 30 MHz to 1000 MHz.
3. The symbol of "<" means "or less".
4. The symbol of ">" means "more than".
5. Calculated result at 42.2 MHz, as the worst point shown on underline:
Antenna Factor + Cable Loss + Meter Reading = 14.1 + 0.9 + 13.4 = 28.4 dB(μV/m)
6. Test receiver setting(s) : CISPR QP 120 kHz (QP : Quasi-Peak)

A.8.2.3 Other Spurious Emission(Above 1000MHz)

Test Date: August 17, 2011

Temp.: 25 °C, Humi: 61 %

Frequency	Antenna Factor	Corr. Factor	Meter Readings [dB(μV)]				Limits		Results		Margin	Remarks
			Horizontal		Vertical		[dB(μV/m)]		[dB(μV/m)]			
	[MHz]	[dB(1/m)]	[dB]	PK	AVE	PK	AVE	PK	AVE	PK	AVE	[dB]
Test condition : Tx Low Ch												
4804.0	27.3	-21.0	< 40.0	< 30.0	< 40.0	< 30.0	74.0	54.0	< 46.3	< 36.3	> +17.7	A/B
12010.0	33.6	-25.9	< 40.0	< 30.0	< 40.0	< 30.0	74.0	54.0	< 47.7	< 37.7	> +16.3	A/B
19216.0	40.2	-21.6	< 40.0	< 30.0	< 40.0	< 30.0	74.0	54.0	< 58.6	< 48.6	> + 5.4	A/B
Test condition : TX Middle Ch												
4882.0	27.3	-21.1	< 40.0	< 30.0	< 40.0	< 30.0	74.0	54.0	< 46.2	< 36.2	> +17.8	A/B
7323.0	29.9	-19.4	< 40.0	< 30.0	< 40.0	< 30.0	74.0	54.0	< 50.5	< 40.5	> +13.5	A/B
12205.0	33.5	-25.8	< 40.0	< 30.0	< 40.0	< 30.0	74.0	54.0	< 47.7	< 37.7	> +16.3	A/B
19528.0	40.3	-21.6	< 40.0	< 30.0	< 40.0	< 30.0	74.0	54.0	< 58.7	< 48.7	> + 5.3	A/B
Test condition : TX High Ch												
4960.0	27.3	-21.2	< 40.0	< 30.0	< 40.0	< 30.0	74.0	54.0	< 46.1	< 36.1	> +17.9	A/B
7440.0	29.9	-19.3	< 40.0	< 30.0	< 40.0	< 30.0	74.0	54.0	< 50.6	< 40.6	> +13.4	A/B
12400.0	33.5	-25.7	< 40.0	< 30.0	40.0	< 30.0	74.0	54.0	< 47.8	< 37.8	> +16.2	A/B
19840.0	40.3	-21.4	< 40.0	< 30.0	< 40.0	< 30.0	74.0	54.0	< 58.9	< 48.9	> + 5.1	A/B
22320.0	40.4	-20.6	< 40.0	< 30.0	< 40.0	< 30.0	74.0	54.0	< 59.8	< 49.8	> + 4.2	A/B

Calculated result at 22320.0 MHz, as the worst point shown on underline:

Antenna Factor = 40.4 dB(1/m)
 Corr. Factor = -20.6 dB
 +) Meter Reading = <30.0 dB(μV)
 Result = <49.8 dB(μV/m)

Minimum Margin: 54.0 - <49.8 =>4.2 (dB)

NOTES

- Test Distance : 3 m
- The spectrum was checked from 1 GHz to 25 GHz (10th harmonic of the highest fundamental frequency).
- The correction factor is shown as follows:
 Corr. Factor [dB] = Cable Loss + 20dB Pad Att. - Pre-Amp. Gain [dB] (1.0 - 7.6GHz)
 Corr. Factor [dB] = Cable Loss + 10dB Pad Att. - Pre-Amp. Gain [dB] (7.6 - 18.0GHz)
 Corr. Factor [dB] = Cable Loss - Pre-Amp. Gain [dB] (over 18 GHz)
- The symbol of "<" means "or less".
- The symbol of ">" means "more than".
- PK : Peak Detector / AVE : Average Detector
- Setting of measuring instrument(s) :

	Detector Function	Resolution B.W.	Video B.W.	Sweep Time
A	Peak	1 MHz	1 MHz	AUTO
B	Peak	1 MHz	10 Hz	AUTO

Test Date: August 17, 2011

Temp.: 25 °C, Humi: 61 %

Frequency [MHz]	Antenna Factor [dB(1/m)]	Corr. Factor [dB]	Meter Readings [dB(μV)]				Limits [dB(μV/m)]		Results [dB(μV/m)]		Margin [dB]	Remarks
			Horizontal		Vertical		PK	AVE	PK	AVE		
			PK	AVE	PK	AVE						
Test condition : RX Middle Ch												
2443.0	21.5	-22.2	43.6	36.8	43.4	36.3	74.0	54.0	42.9	36.1	+17.9	A/B
4886.0	27.3	-21.4	< 40.0	< 30.0	< 40.0	< 30.0	74.0	54.0	< 45.9	< 35.9	> +18.1	A/B
7329.0	29.9	-19.7	< 40.0	< 30.0	< 40.0	< 30.0	74.0	54.0	< 50.2	< 40.2	> +13.8	A/B

Calculated result at 7329.0 MHz, as the worst point shown on underline:

Antenna Factor = 29.9 dB(1/m)

Corr. Factor = -19.7 dB

+) Meter Reading = <30.0 dB(μV)

Result = <40.2 dB(μV/m)

Minimum Margin: 54.0 - <40.2 = >13.8 (dB)

NOTES

- Test Distance : 3 m
- The spectrum was checked from 1 GHz to 7.5 GHz .
- The correction factor is shown as follows:
Corr. Factor [dB] = Cable Loss + 20dB Pad Att. - Pre-Amp. Gain [dB] (1.0 - 7.6GHz)
- The symbol of "<" means "or less".
- The symbol of ">" means "more than".
- PK : Peak Detector / AVE : Average Detector
- Setting of measuring instrument(s) :

	Detector Function	Resolution B.W.	Video B.W.	Sweep Time
A	Peak	1 MHz	1 MHz	AUTO
B	Peak	1 MHz	10 Hz	AUTO

Appendix B: Test Arrangement (Photographs)**B.1 AC Powerline Conducted Emission**

This page is CONFIDENTIAL.

B.2 Radiated Emission

This page is CONFIDENTIAL.

Appendix C: Test Instruments**C.1 Channel Separation**

Type	Model	Manufacturer	ID No.	Last Cal.	Interval
Spectrum Analyzer	E4446A	Agilent	A-39	2010/9	1 Year
Attenuator	54A-10	Weinschel	D-29	2010/10	1 Year
RF Cable	SUCOFLEX102	SUHNER	C-52	2011/6	1 Year

C.2 Minimum Hopping Channel

Type	Model	Manufacturer	ID No.	Last Cal.	Interval
Spectrum Analyzer	E4446A	Agilent	A-39	2010/9	1 Year
Attenuator	54A-10	Weinschel	D-29	2010/10	1 Year
RF Cable	SUCOFLEX102	SUHNER	C-52	2011/6	1 Year

C.3 Occupied Bandwidth

Type	Model	Manufacturer	ID No.	Last Cal.	Interval
Spectrum Analyzer	E4446A	Agilent	A-39	2010/9	1 Year
Attenuator	54A-10	Weinschel	D-29	2010/10	1 Year
RF Cable	SUCOFLEX102	SUHNER	C-52	2011/6	1 Year

C.4 Dwell Time

Type	Model	Manufacturer	ID No.	Last Cal.	Interval
Spectrum Analyzer	E4446A	Agilent	A-39	2010/9	1 Year
Attenuator	54A-10	Weinschel	D-29	2010/10	1 Year
RF Cable	SUCOFLEX102	SUHNER	C-52	2011/6	1 Year

C.5 Peak Output Power (Conduction)

Type	Model	Manufacturer	ID No.	Last Cal.	Interval
Power Meter	ML2495A	Anritsu	100-02-507E0	2010/12	1 Year
Power Sensor	MA2491A	Anritsu	100-02-507E0	2010/12	1 Year
Attenuator	54A-10	Weinschel	D-29	2010/10	1 Year
RF Cable	SUCOFLEX102	SUHNER	C-52	2011/6	1 Year

C.6 Spurious Emission (Conduction)

Type	Model	Manufacturer	ID No.	Last Cal.	Interval
Spectrum Analyzer	E4446A	Agilent	A-39	2010/9	1 Year
Attenuator	54A-10	Weinschel	D-29	2010/10	1 Year
RF Cable	SUCOFLEX102	SUHNER	C-52	2011/6	1 Year

C.7 AC Power Conducted Emission

Type	Model	Manufacturer	ID No.	Last Cal.	Interval
Test Receiver	ESCI 7	Rohde & Schwarz	A-8	2011/1	1 Year
AMN (main)	KNW-407R	Kyoritsu	D-39	2010/9	1 Year
Attenuator	MP721C	Anritsu	D-105	2010/9	1 Year
RF Cable	5D-2W	FUJIKURA	H-33	2011/6	1 Year

C.8 Radiated Emission

C.8.1 Radiated Emission 9 kHz – 30 MHz

Type	Model	Manufacturer	ID No.	Last Cal.	Interval
Test Receiver	ESCI 7	Rohde & Schwarz	A-8	2011/1	1 Year
Loop Antenna	HFH2-Z2	Rohde & Schwarz	C-2	2011/8	1 Year
RF Cable	RG213/U	SUHNER	H-28	2011/8	1 Year

C.8.2 Radiated Emission 30MHz – 1000 MHz

Type	Model	Manufacturer	ID No.	Last Cal.	Interval
Test Receiver	ESCI 7	Rohde & Schwarz	A-8	2011/1	1 Year
Biconical Antenna	VHA9103/BBA9106	Schwarzbeck	C-30	2011/5	1 Year
Log-periodic Antenna	UHALP9108-A1	Schwarzbeck	C-31	2011/5	1 Year
RF Cable	S 10162 B-11 etc.	SUHNER	H-4	2011/3	1 Year
Site Attenuation	--	----	H-15	2011/2	1 Year

C.8.3 Radiated Emission Above 1000 MHz

Type	Model	Manufacturer	ID No.	Last Cal.	Interval
Test Receiver	ESU 26	Rohde & Schwarz	A-6	2011/5	1 Year
RF Cable	SUCOFLEX104	SUHNER	C-40-11	2010/12	1 Year
RF Cable	SUCOFLEX104	SUHNER	C-40-14	2010/12	1 Year
RF Cable	SUCOFLEX102	SUHNER	C-54	2010/12	1 Year
RF Cable	SUCOFLEX102EA	SUHNER	C-69	2010/12	1 Year
Attenuator	2-10	Weinschel	D-79	2010/10	1 Year
Attenuator	54-10	Weinschel	D-28	2010/9	1 Year
Pre-Amplifier	WJ-6611-513	Watkins Johnson	A-23	2010/12	1 Year
Pre-Amplifier	WJ-6882-824	Watkins Johnson	A-21	2010/12	1 Year
Pre-Amplifier	DBL-0618N515	DBS Microwave	A-33	2010/12	1 Year
Pre-Amplifier	BZ1804LD1	B&T Technologies	A-29	2010/12	1 Year
Band Rejection Filter	BRM50701	MICRO-TRONICS	D-93	2011/2	1 Year
Horn Antenna	91888-2	EATON	C-41-1	2011/6	1 Year
Horn Antenna	91889-2	EATON	C-41-2	2011/6	1 Year
Horn Antenna	3160-05	EMCO	C-55	2011/6	2 Years
Horn Antenna	3160-06	EMCO	C-57	2011/6	2 Years
Horn Antenna	3160-07	EMCO	C-58	2011/6	2 Years
Horn Antenna	3160-08	EMCO	C-59	2011/6	2 Years
Horn Antenna	3160-09	EMCO	C-48	2011/6	2 Years